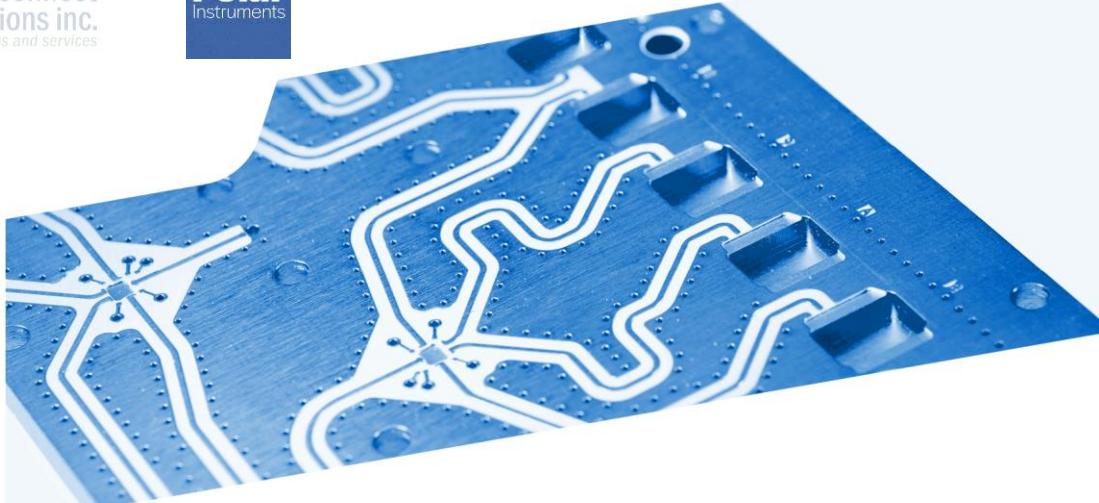
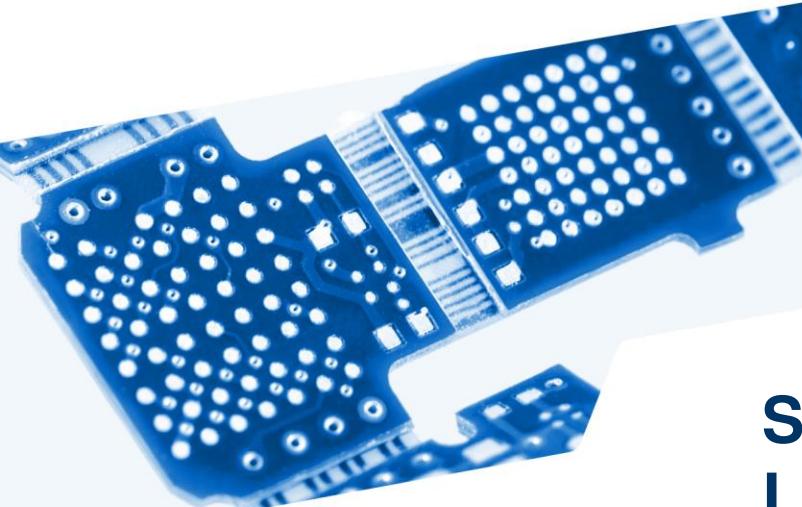


Optiprint



瑞士 Innovative PCB Solutions



→ optiprint.ch

**Sichern der Zuverlässigkeit für
Leiterplatten mittels
Interconnect Stress Test
Zeitbeschleunigt**

Optiprint AG - Facts

- **Established 1985**
- **Located in North-East Switzerland**
- **Privately-owned, managed in 2nd generation**
- **130 employees, low fluctuation rate < 3 %**
- **Prime products; high-end RF/microwave / mm-Wave & HDI flex / flex-rigid PCB**
- **Continuous investment in plant & equipment (≈ 10% of turnover)**
- **State-of-art kit in all process stages, key being machining, imaging, etching, lamination, electrical test & metrology**
- **Clean, modern facility**



Company Milestones



foundation



new facility



facility extension

1985

1998

2000

2012

■ first generation



■ second generation



Industries

With an export share of about 80 % Optiprint AG supplies the following markets:



Medical technology



Telecommunication



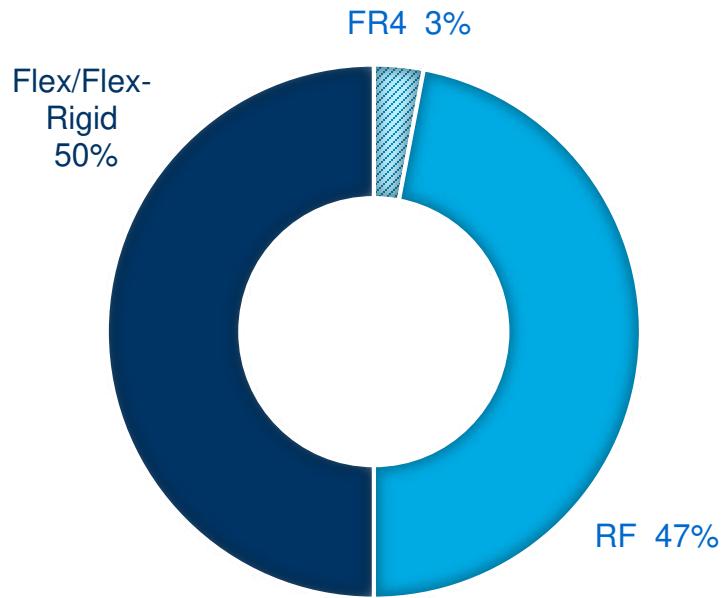
Safety technology



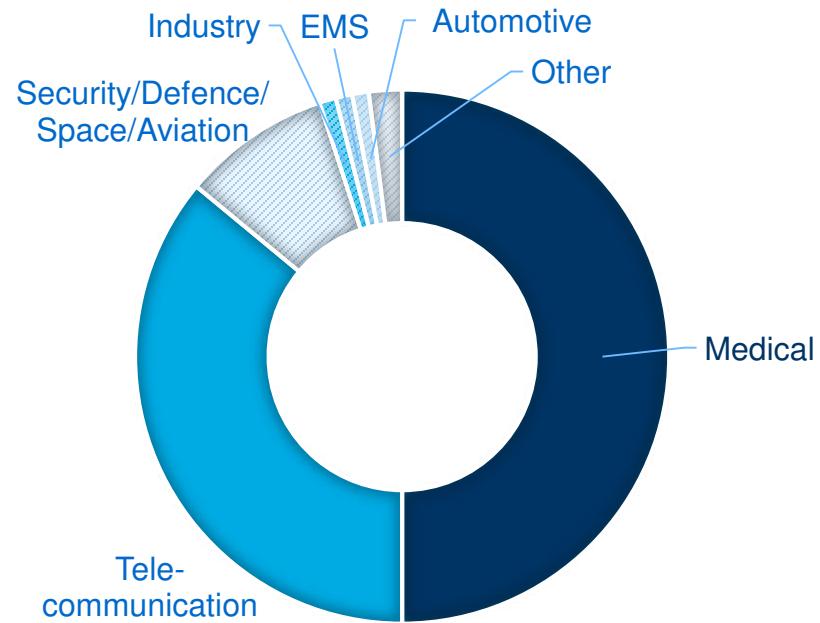
Aerospace



Products - Markets



PRODUCTS



MARKETS

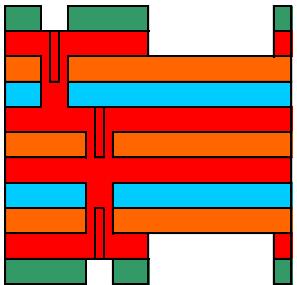
Trends in the PCB industry

- **Miniaturisation**
- **Modularisation / Integration**
- **New processes**
- **New laminate materials (next gen.)**
- **New surface finishes (e.g. DIG)**
- ...



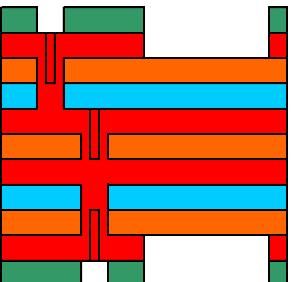
Miniaturisation

Build-up



Thickness: 0.210mm

Soldermask	0.020
Copper	0.022
Polyimide	0.012
Adhesive	0.025
Copper	0.022
Polyimide	0.025
Copper	0.022
Adhesive	0.025
Polyimide	0.012
Copper	0.022
Soldermask	0.020



Thickness: 0.135mm

Design Rules

Line / Space **75 / 75 µm**

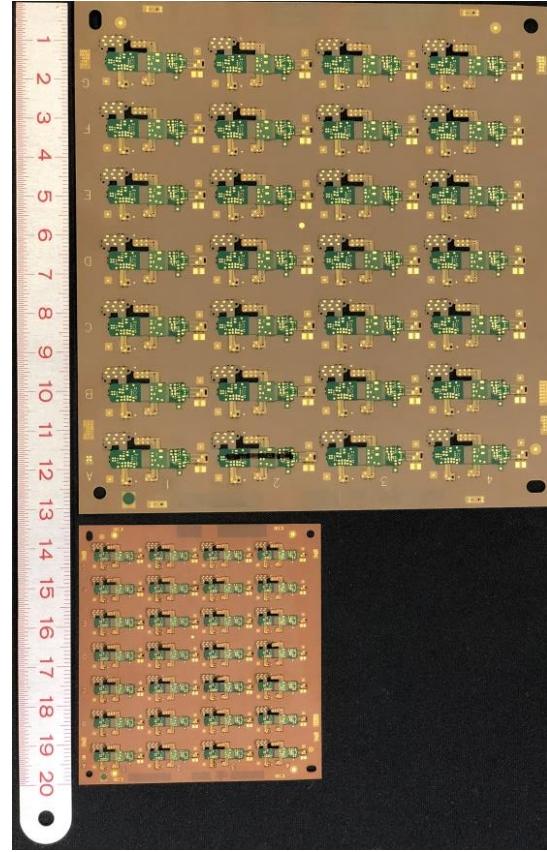
Via Ø **75 µm**

Pad Ø **200 µm**

Line / Space **38 / 38 µm**

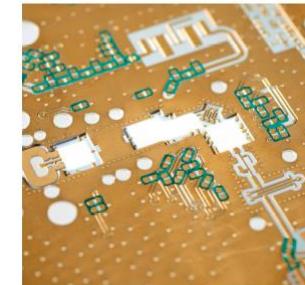
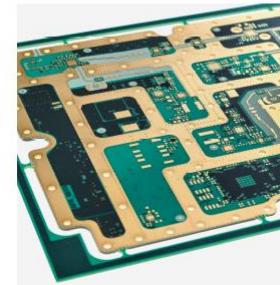
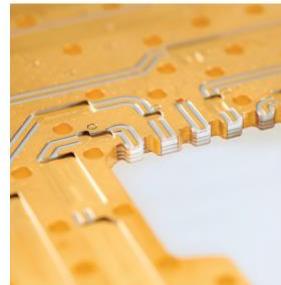
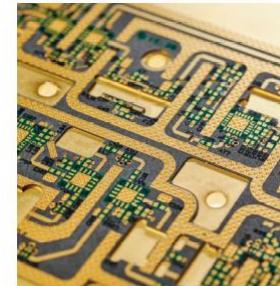
Via Ø **25 µm**

Pad Ø **100 µm**



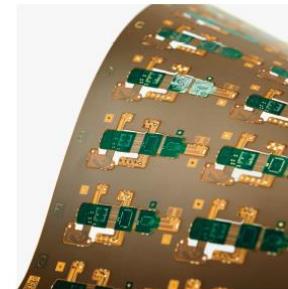
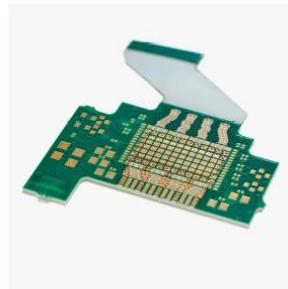
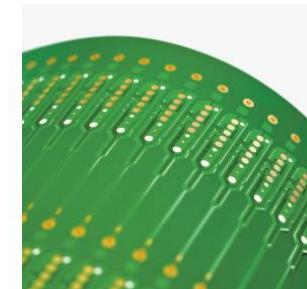
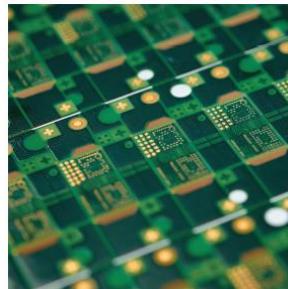
High frequency PCBs

- **high stock level of different RF-materials**
- **high etching accuracy**
- **PTFE, ceramic, foam**
- **burried / filled / overplated vias**
- **stacked microvias**
- **trough hole filling (Cu or epoxy)**
- **metal core PCB**
- **integrated heatsink**
- **integrated components**
- **resistive foil**



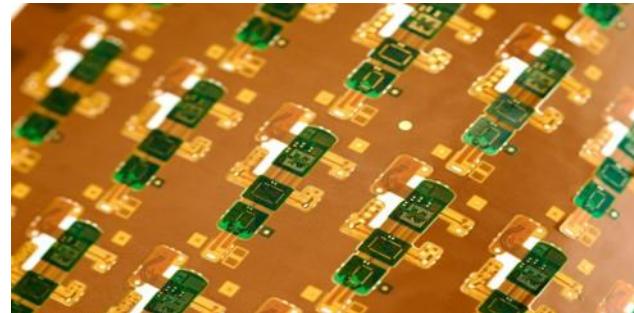
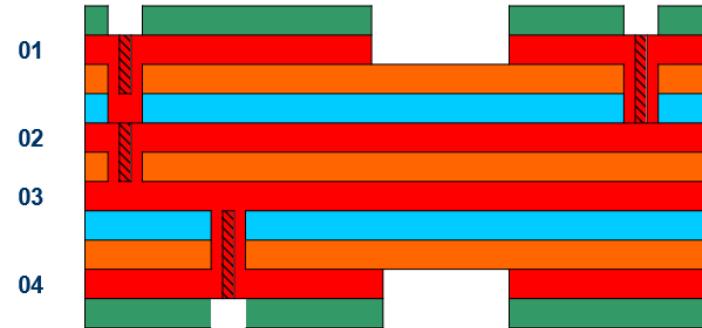
Flexible and flex-rigid PCBs

- **very fine line / space (<25µm)**
- **very thin laminates**
 - 12µm PI core
 - 4 layers = 135µm incl. SM
- **filled and stacked microvias**
- **via in pad**
- **laser cut outline ± 25µm**



Sample: 4-layer rigid-flex board

- **4-layer full-flex rigid-flex PCB**
- **Dupont / Thinflex Polyimide**
- **Board thickness 0.135 mm**
- **Solder mask defined pads**
- **Line / space: down to 25 µm**
- **Copper thickness 8 – 18 µm**
- **Stacked and Staggered via technology**



Surface finish

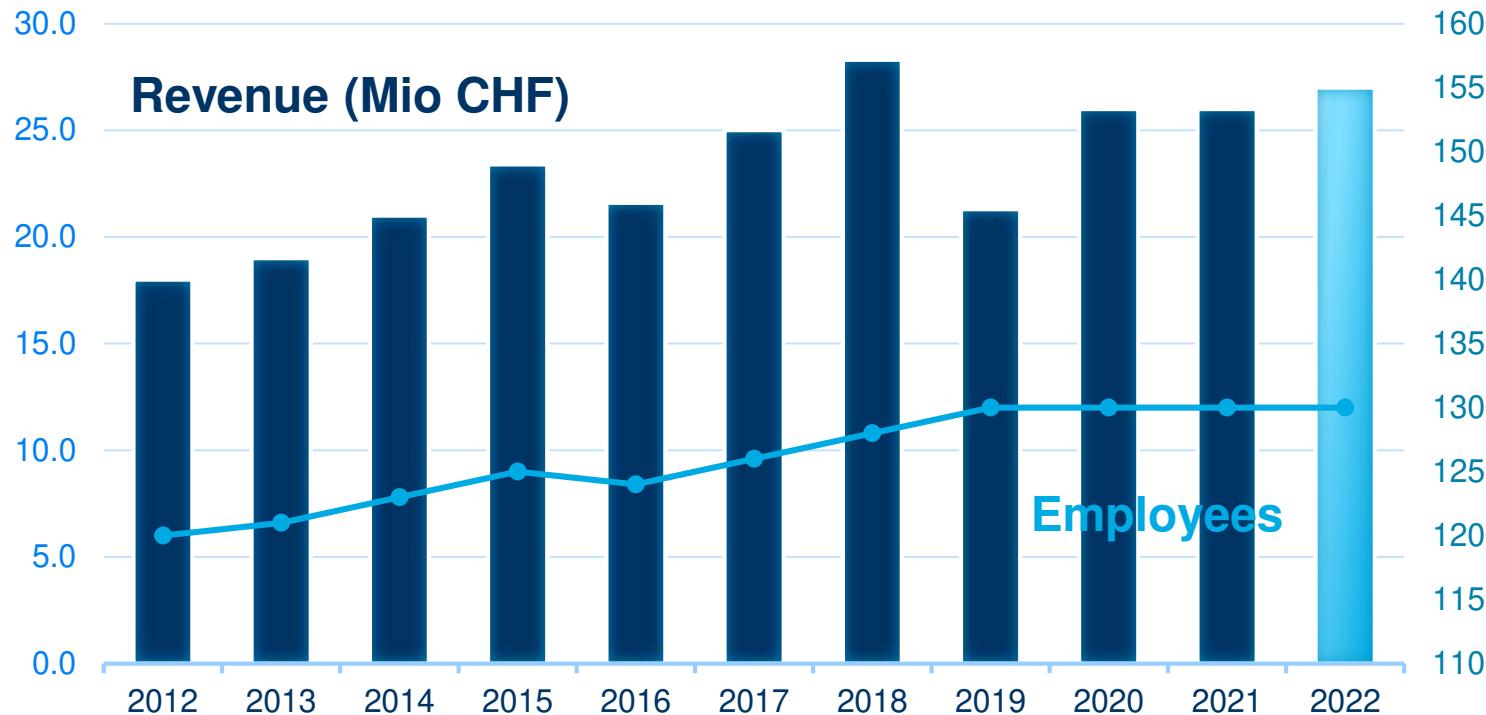
Properties	ENIG	ENEPIG	ISIG	ENIGEG	ENEPIG	EPIG	DIG	Galv Ni/Au	Chem Ag	Chem Sn
	in-house	in-house	in-house	in-house	external	external	external	external	external	external
Wire Bonding	yes	yes	yes	Yes	yes	yes	yes	yes	no	no
Metal	Ni/Au	Ni/Pd/Au	Ag/Au	Ni/Au	Ni/Pd/Au	Pd/Au	Au	Ni/Au	Ag	Sn
Typical Thickness	Ni 3-7µm Au 0.05- 0.1µm	Ni 3-7µm/ Pd 0.2-0.5µm/ Au ≥0.010	Ag 0.1-0.4µm Au 0.1-0.2µm	Ni 3-7µm/ Au 0.4-1.1µm	Ni 3- 7µm/ Pd 0.08- 0.3µm Au 0.03- 0.08µm	Pd 0.1-0.2µm Au 0.1-0.2µm	Au 0.2-0.3µm	Ni 3-10µm Au 0.1- 10µm	Ag 0.15-0.4µm	0.6- 1.2µm

Production Processes

- **Automation**
- **Direct Processes**
 - Inkjet, LDI, 3D Printing
- **Traceability**
- **Laser tooling**
 - Nano → Pico → Femto
- **More Inspections/Tests (automatic and manual)**



Revenue/Sales - Employees



Anforderungen an die LP nach der Herstellung?

Thermische Belastung bei der Bestückung	Thermische Belastung im Betrieb
Verschiedene Lötprozesse	Temperaturschwankungen <ul style="list-style-type: none">• Betriebstemperatur• Ruhetemperatur
Hohe Temp – ab 230°C	
Reparaturarbeiten <ul style="list-style-type: none">• 6x Reflow bei 260°C	
Einbau <ul style="list-style-type: none">• Statische und Dynamische Biegung	

Überlebensfähigkeit vs. Zuverlässigkeit

Rework Zyklen bestehen während der Bestückung → **Überlebensfähigkeit**

Thermische Belastung in der Endanwendung
überstehen → **Zuverlässigkeit**

Testmethoden

Temperaturwechseltest (TWT)

Prüfling wird wechselweise in zwei Klimakammern mit **-40°C** und **+125°C** eingefahren

IST Interconnect Stress Test

Elektrische Aufheizung des Coupons auf **150°C** für 3 Minuten, Abkühlung auf Raumtemperatur in 2 Minuten

The Institute for Interconnecting and Packaging Electronic Circuits
2215 Sanders Road Northbrook IL 60062-6135

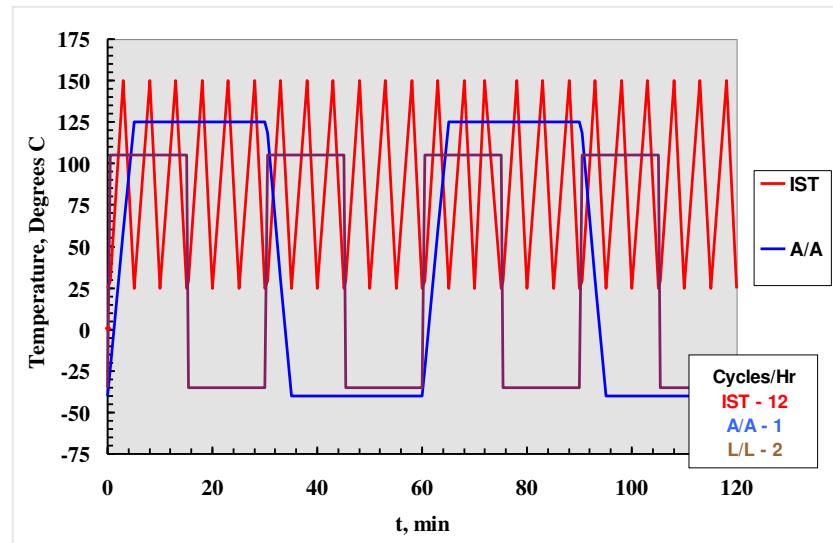


IPC-TM-650
Test Methods Manual

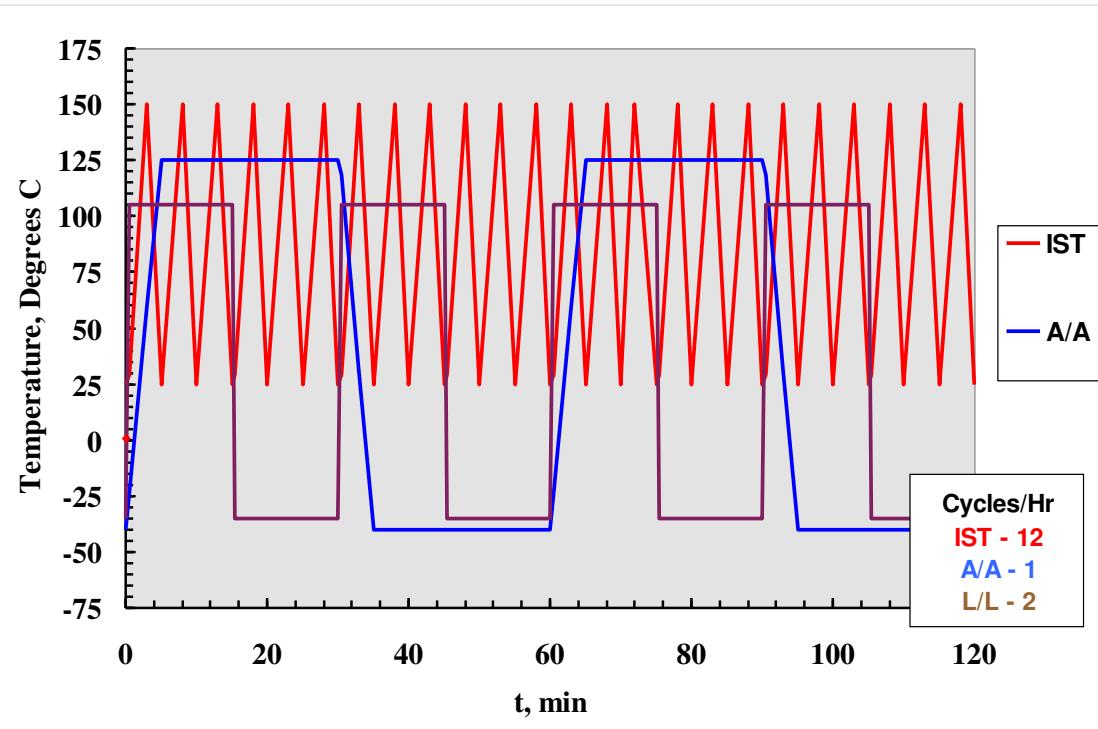
Number 2.6.26	
Subject	
DC Current Induced Thermal Cycling Test	
Date	Revision
11/99	Proposal
Originating Committee: Test Methods Subcommittee (7-11)	

Vergleich TWT vs. IST

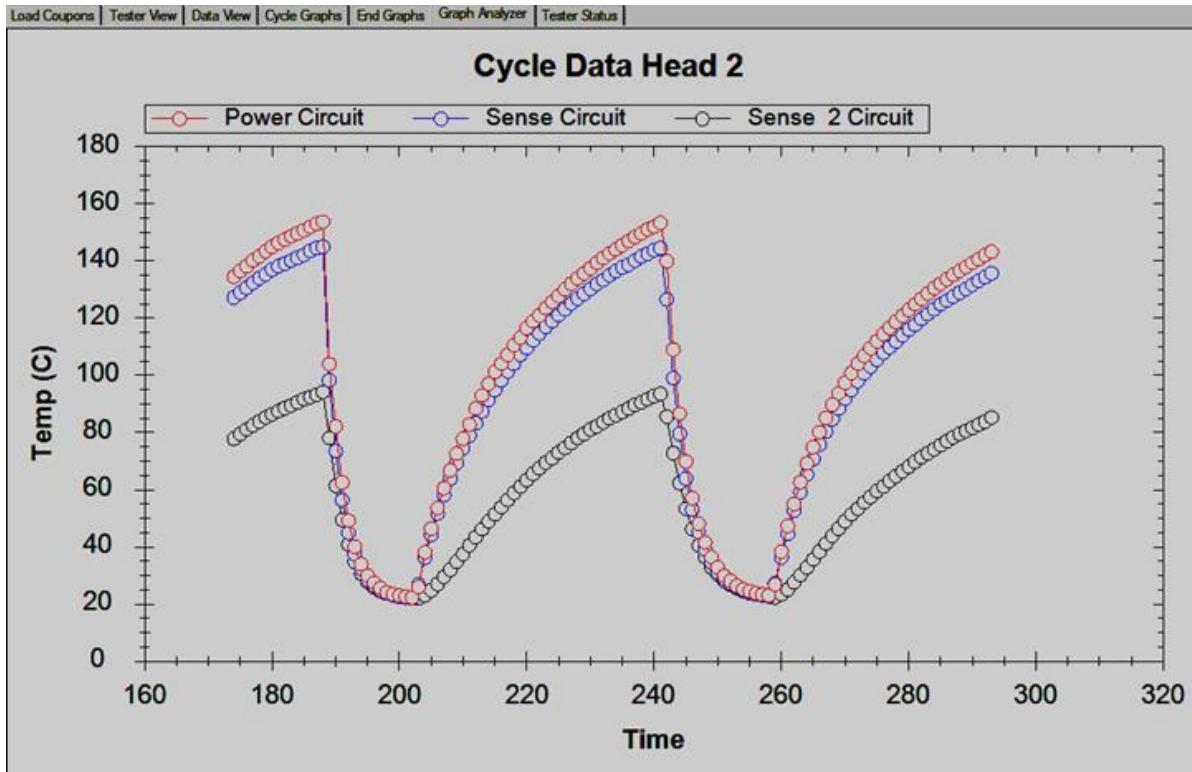
- TWT testet in Negativtemp. **mit** Verweilzeit
 - IST testet ab Raumtemp. **ohne** Verweilzeit
- Deutlich kürzere Zykluszeiten



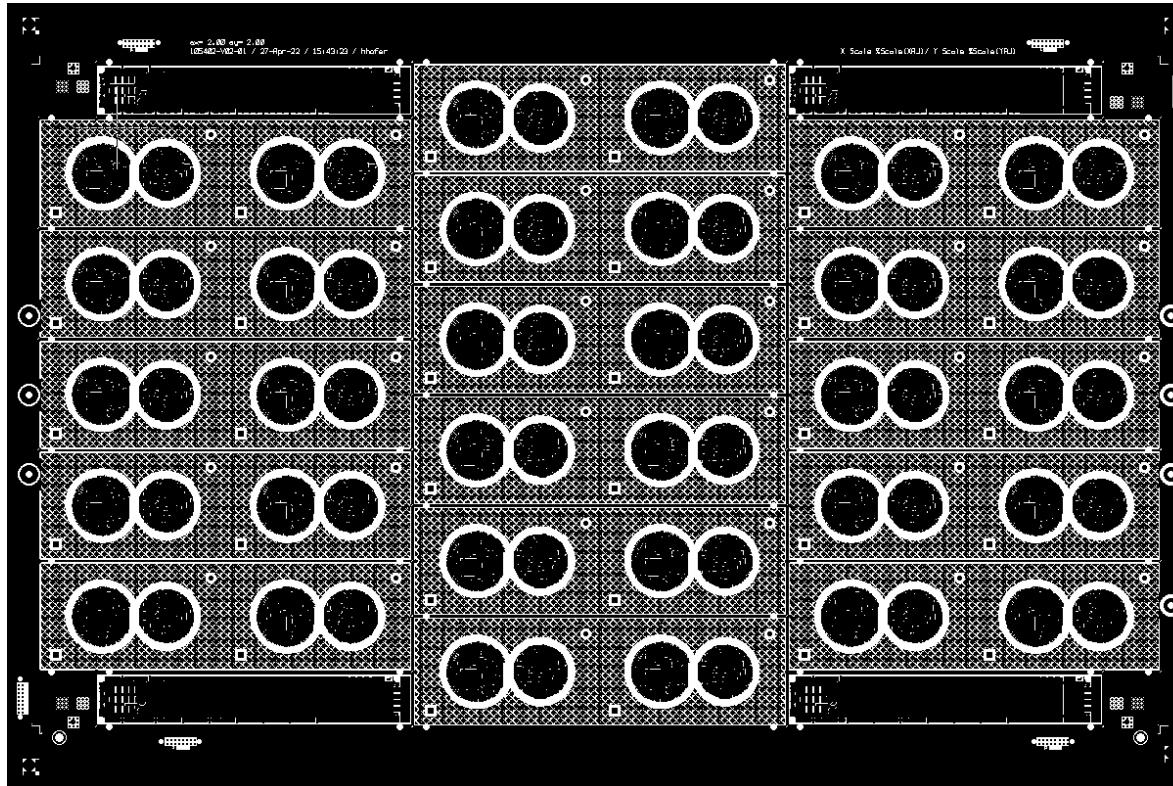
Vergleich TWT vs. IST



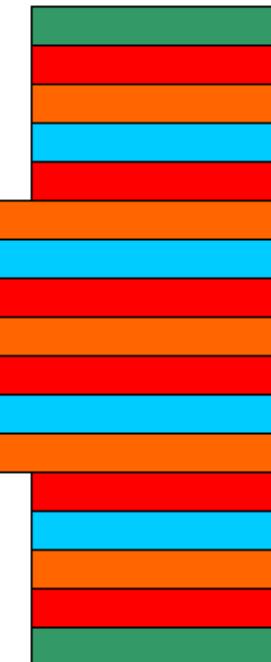
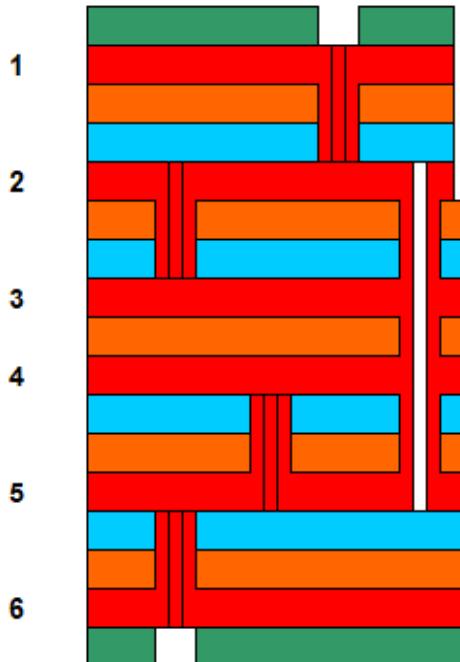
Temperaturverläufe am Coupon



Positionierung im Panel

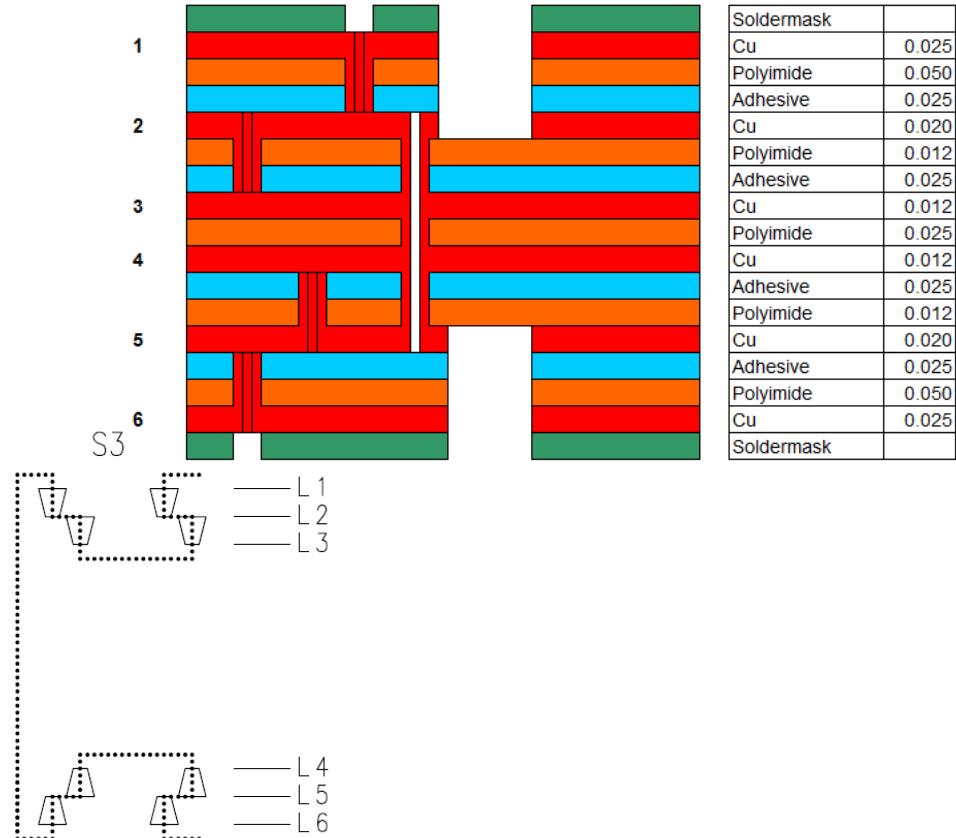
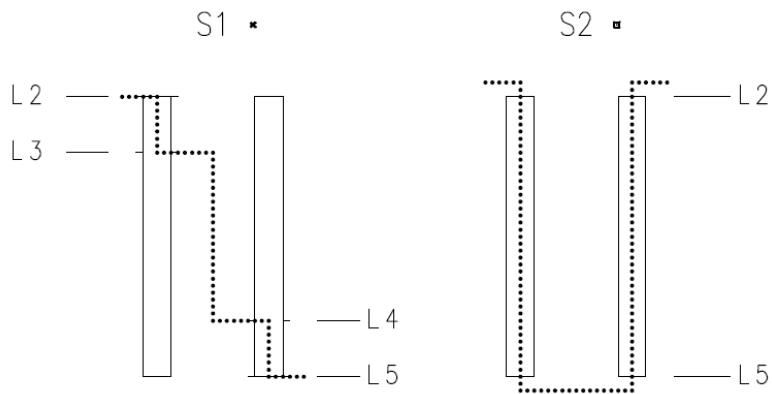


6-Layer with buried and staggered vias

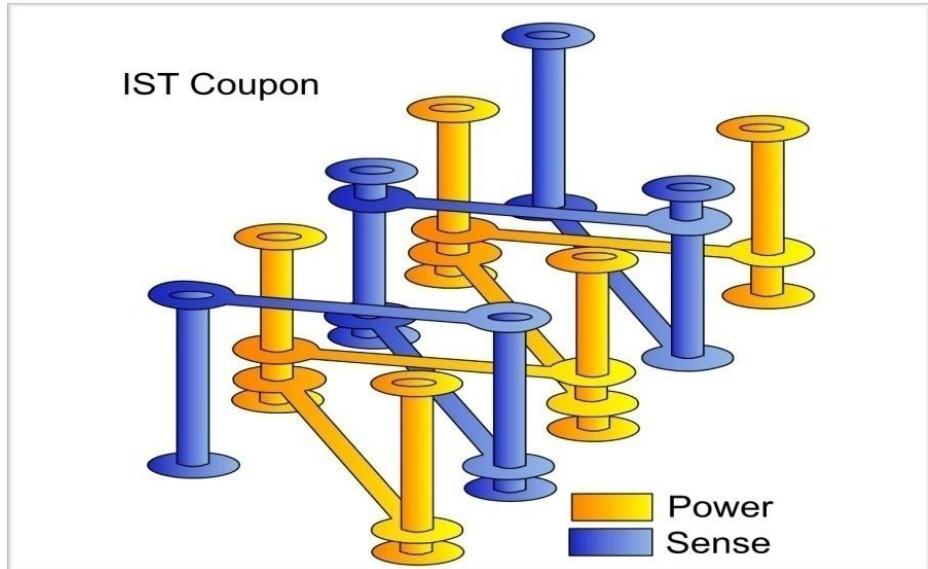
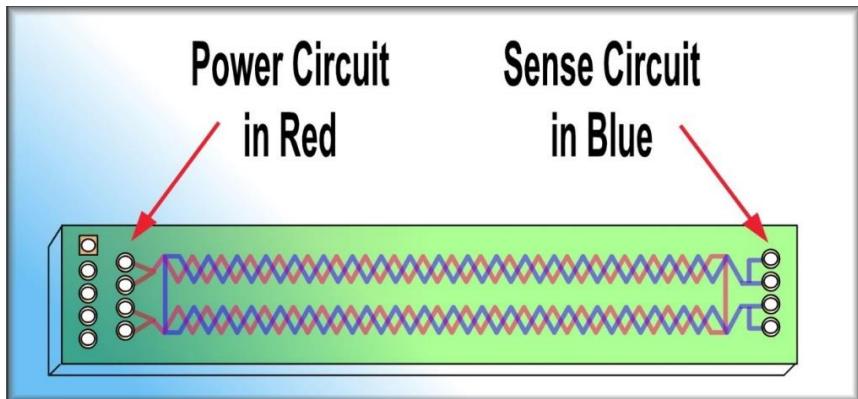


Soldermask	
Cu	0.025
Polyimide	0.050
Adhesive	0.025
Cu	0.020
Polyimide	0.012
Adhesive	0.025
Cu	0.012
Polyimide	0.025
Cu	0.012
Adhesive	0.025
Polyimide	0.012
Cu	0.020
Adhesive	0.025
Polyimide	0.050
Cu	0.025
Soldermask	

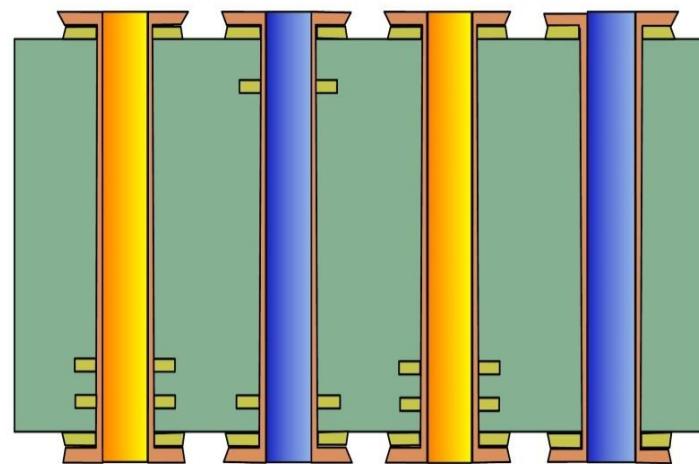
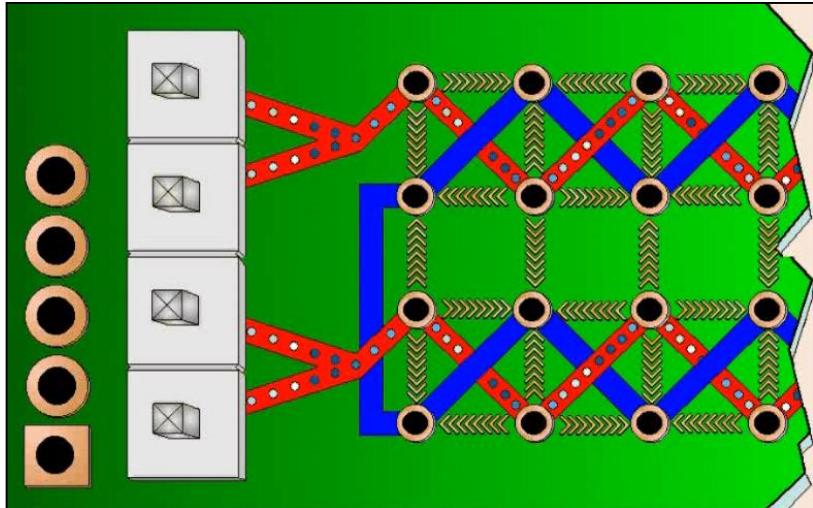
Messkreise im Coupon



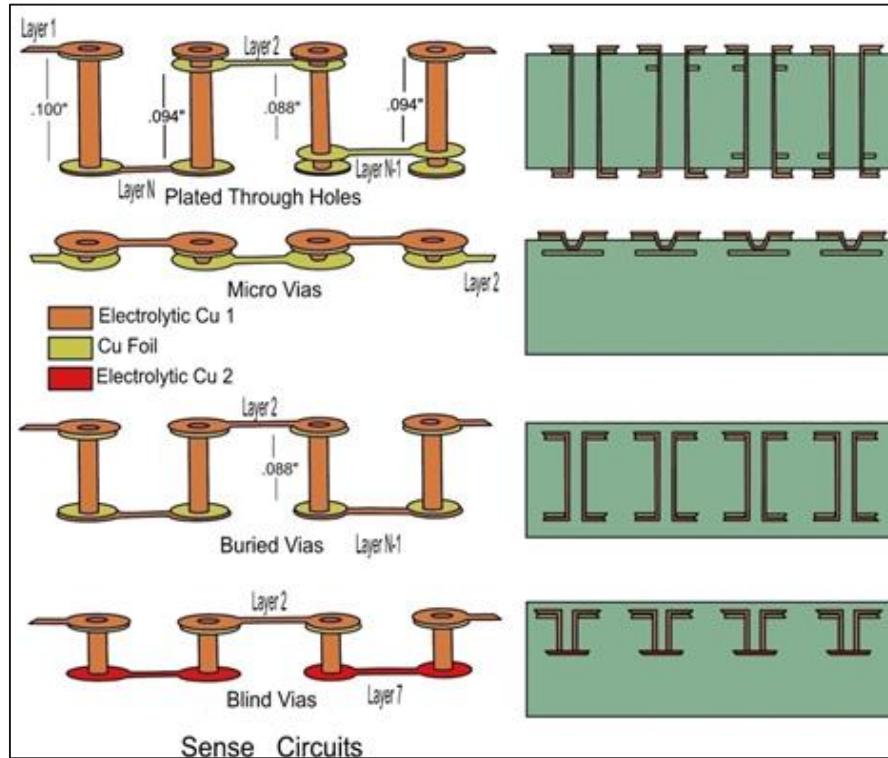
IST Coupon



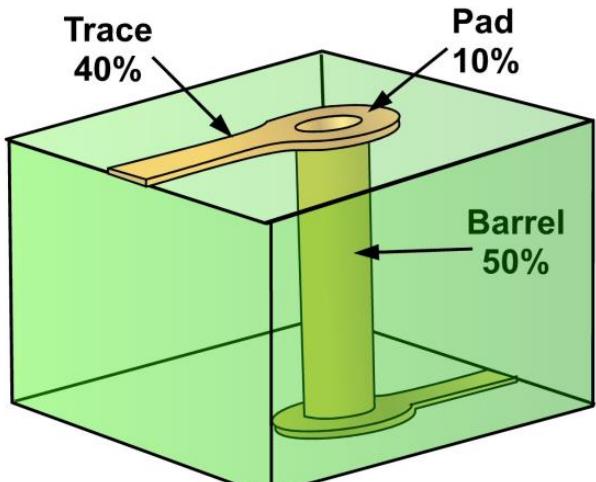
IST Coupon



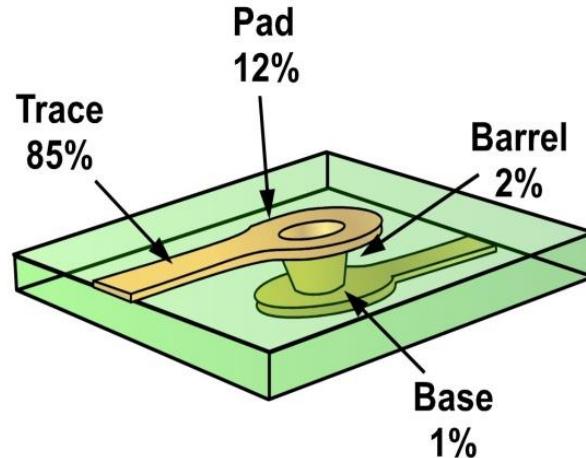
Messkreise im Coupon



Coupon Design für optimale Widerstandsverteilung in der Daisy-Chain

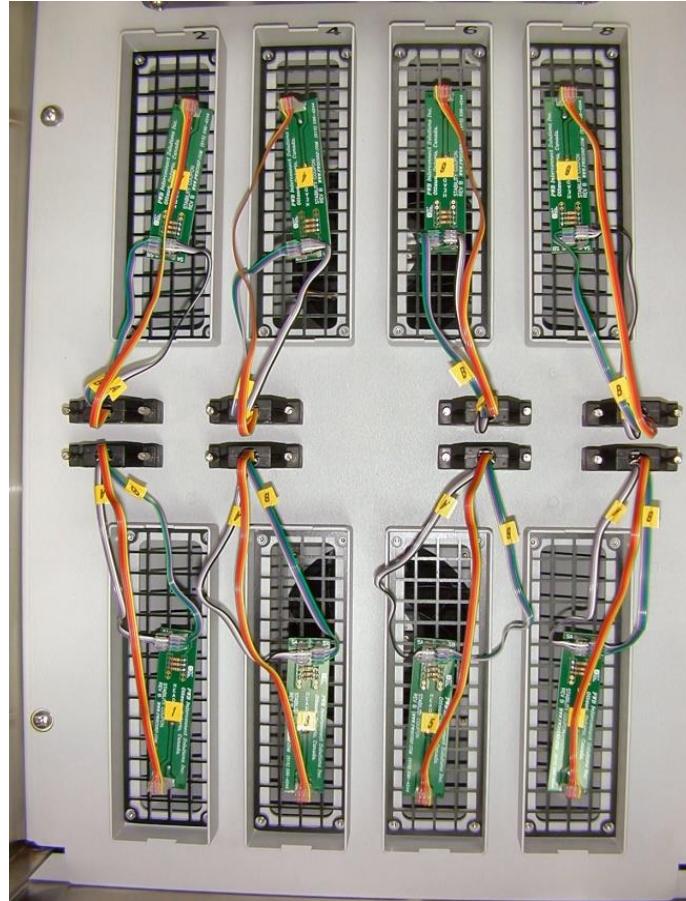


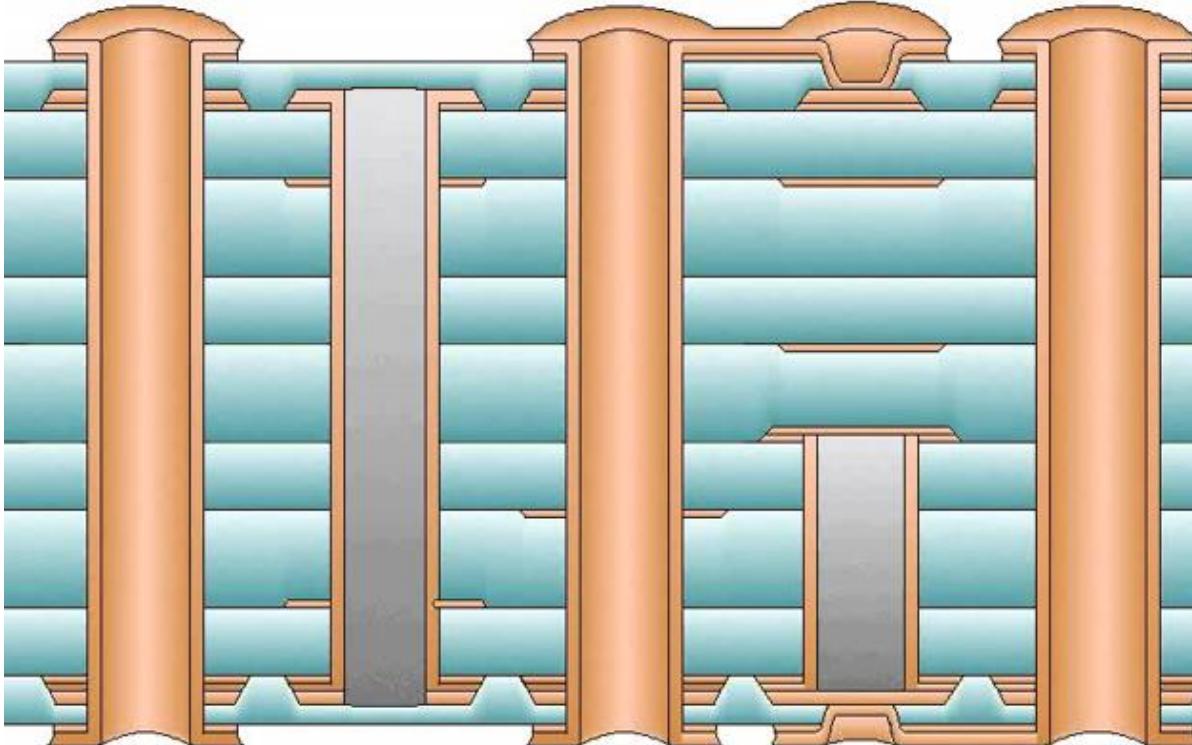
**Resistance Distribution
Plated Through Hole (PTH)**

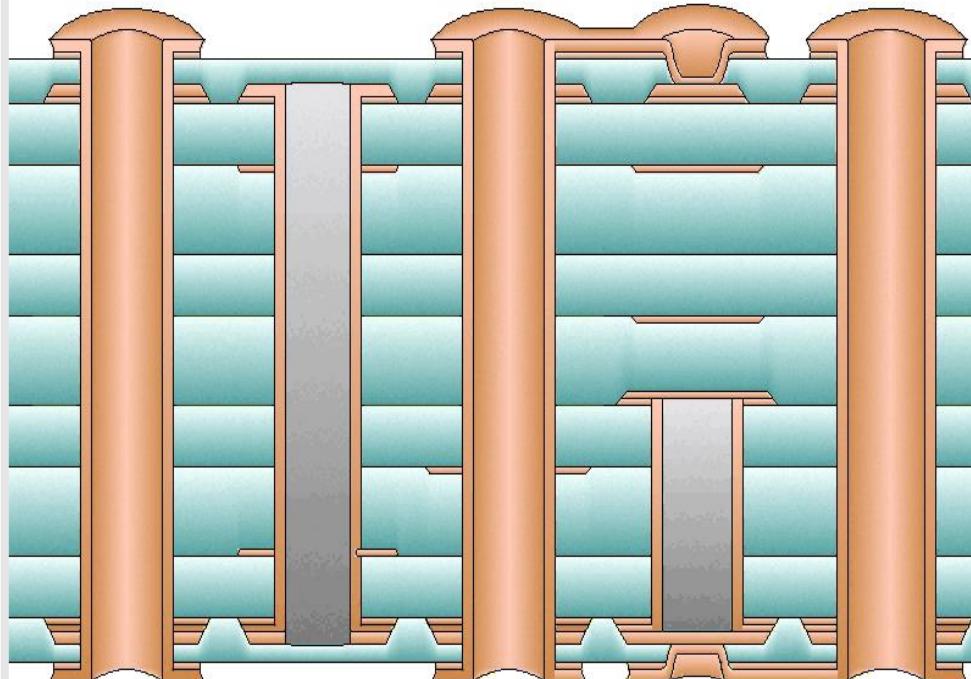


**Resistance Distribution
Microvia**

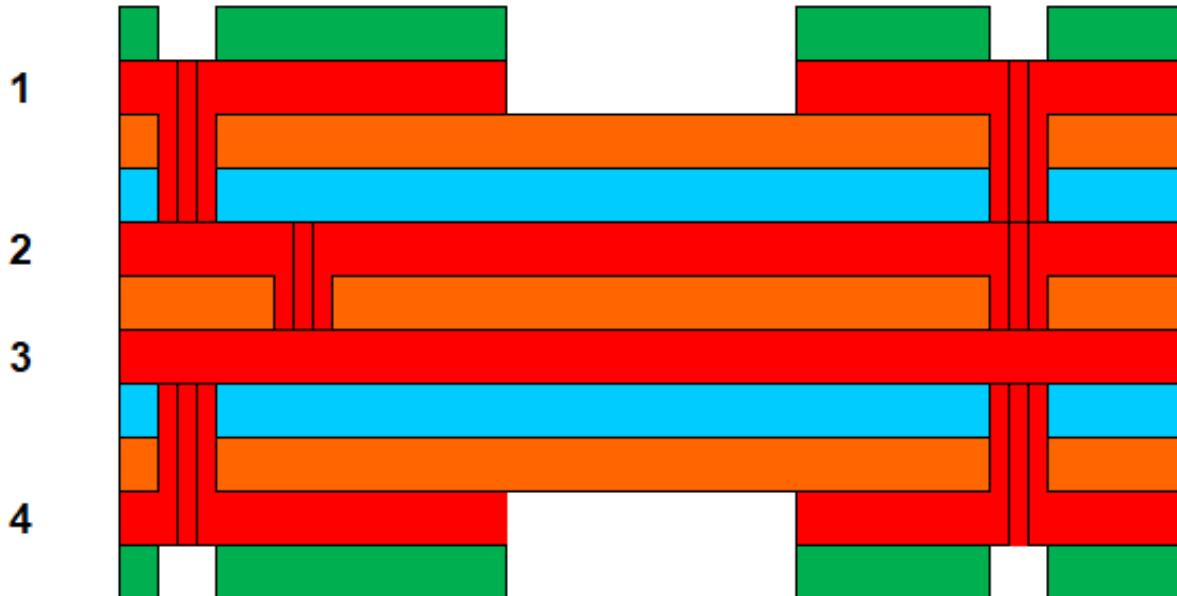
IST Tester





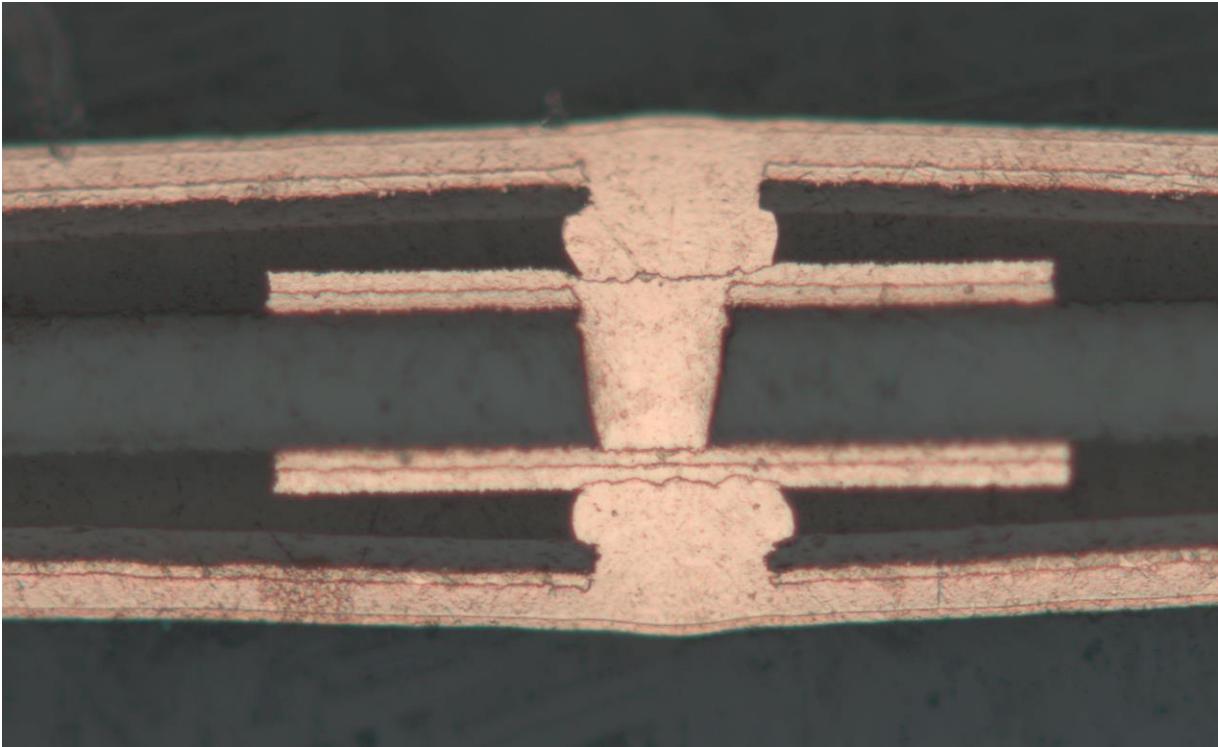


4-Layer with stacked and staggered vias

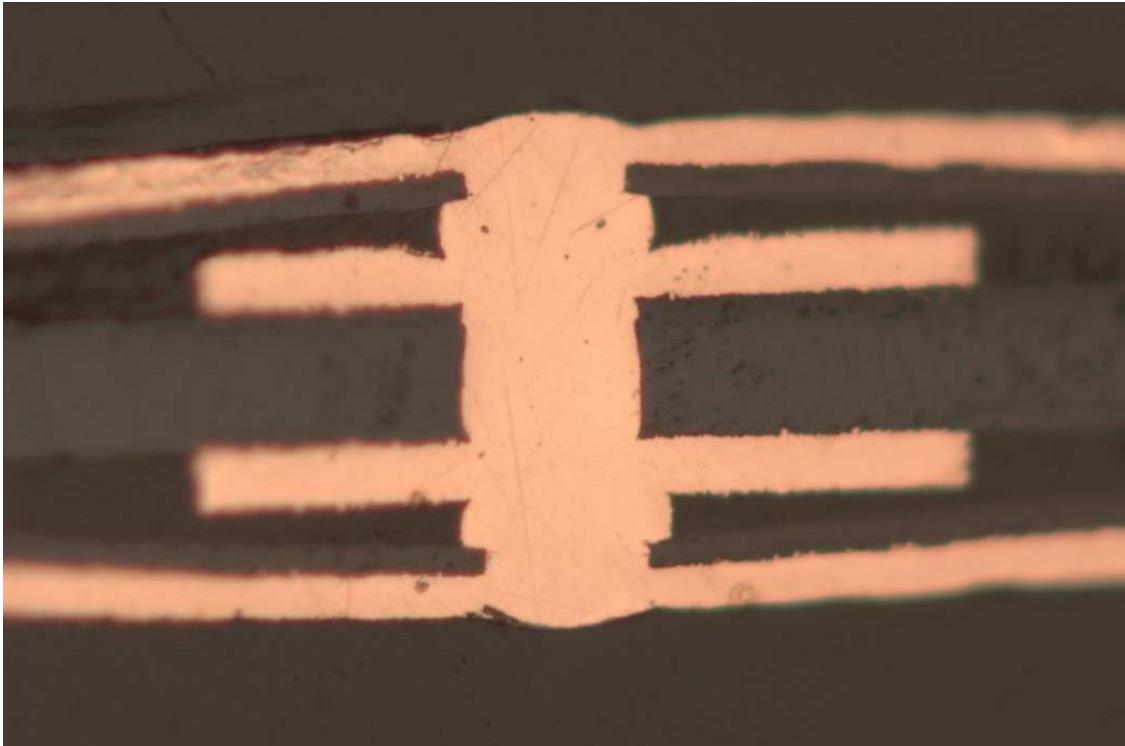


Soldermask	0.020
Copper	0.020
Polyimide	0.013
Adhesive	0.025
Copper	0.015
Polyimide	0.025
Copper	0.015
Adhesive	0.025
Polyimide	0.013
Copper	0.020
Soldermask	0.020

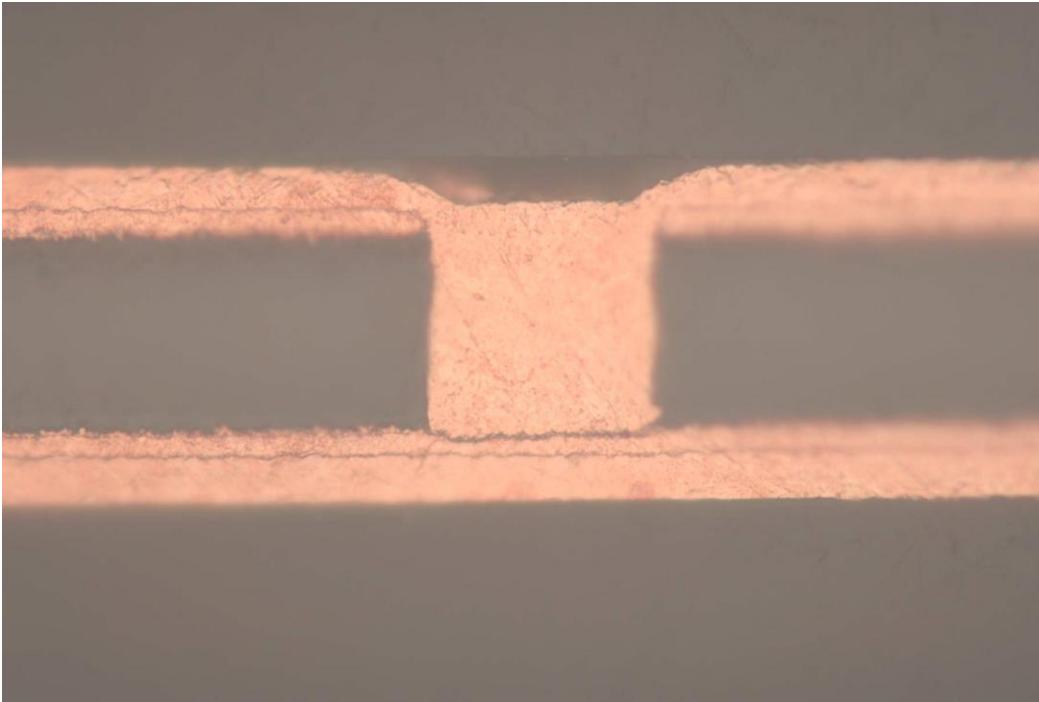
Cross Section 4-Layer with stacked vias (via in pad)



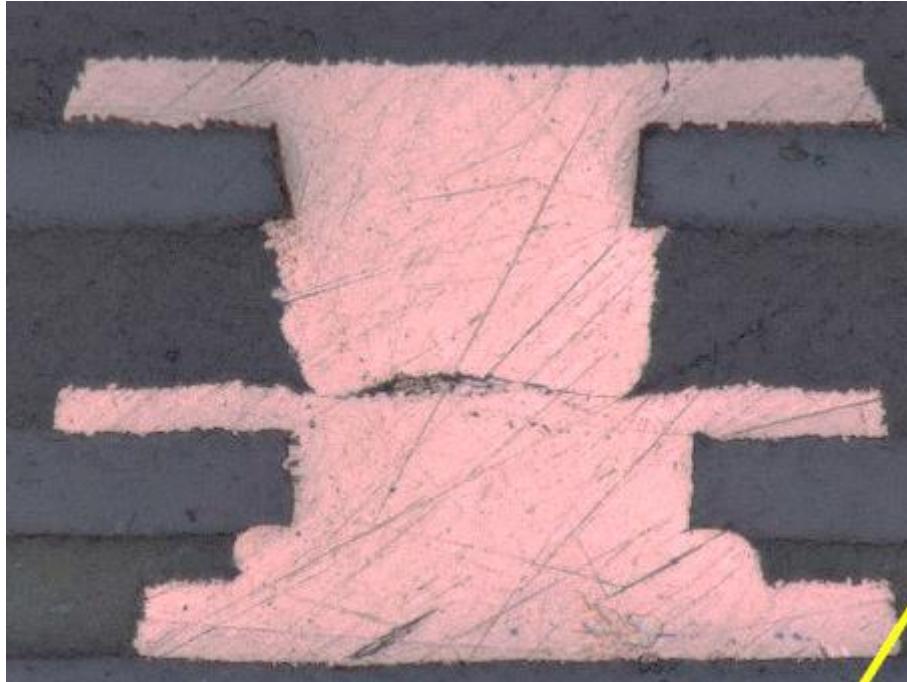
Cross Section 4-Layer with stacked vias (via in pad)

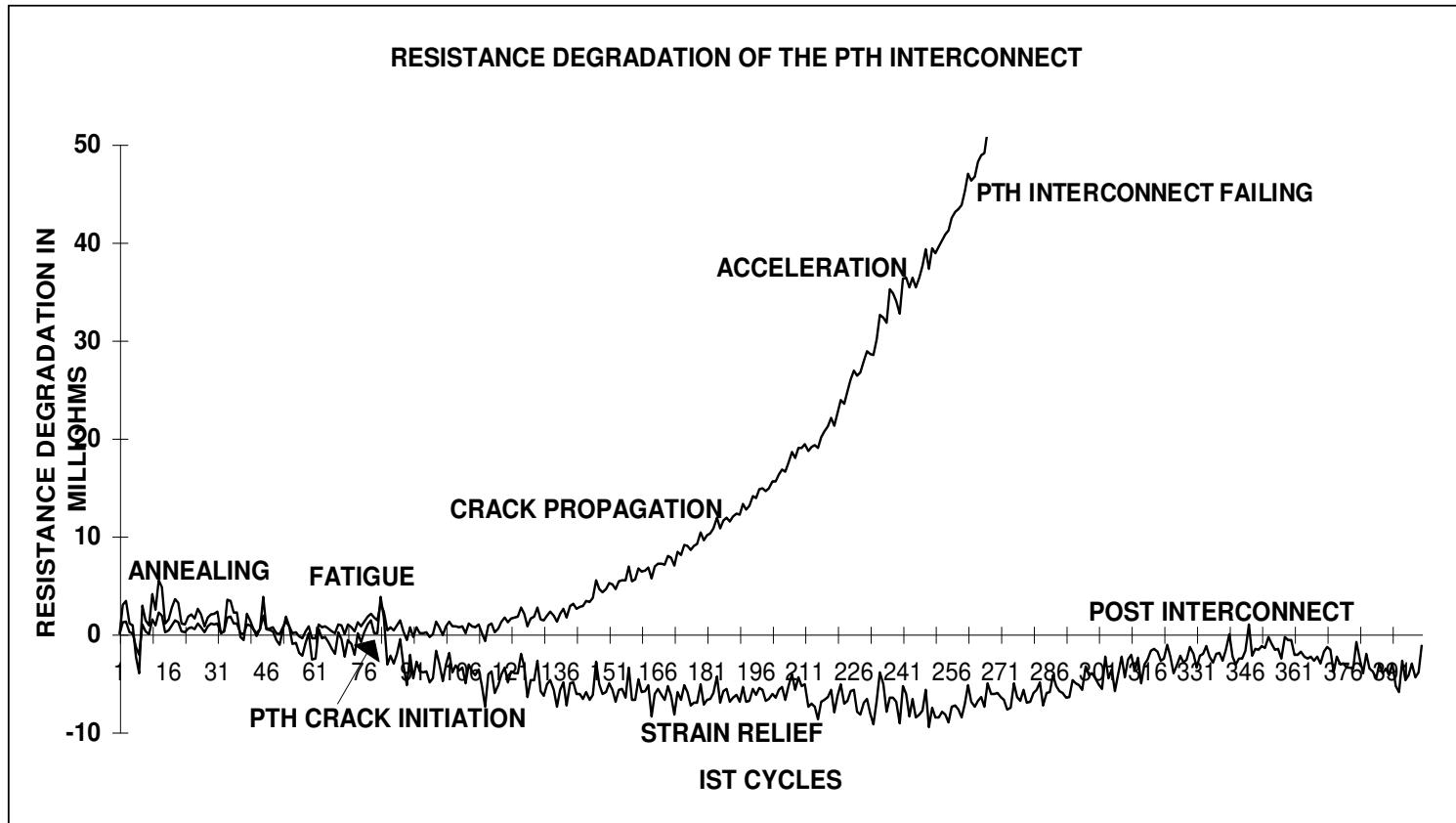


Cross Section

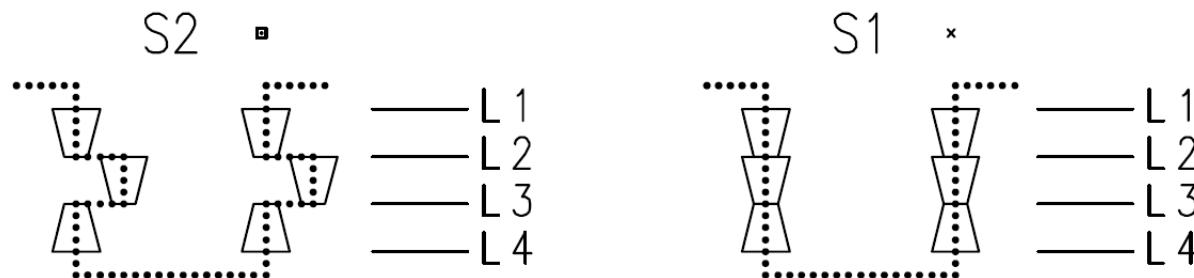
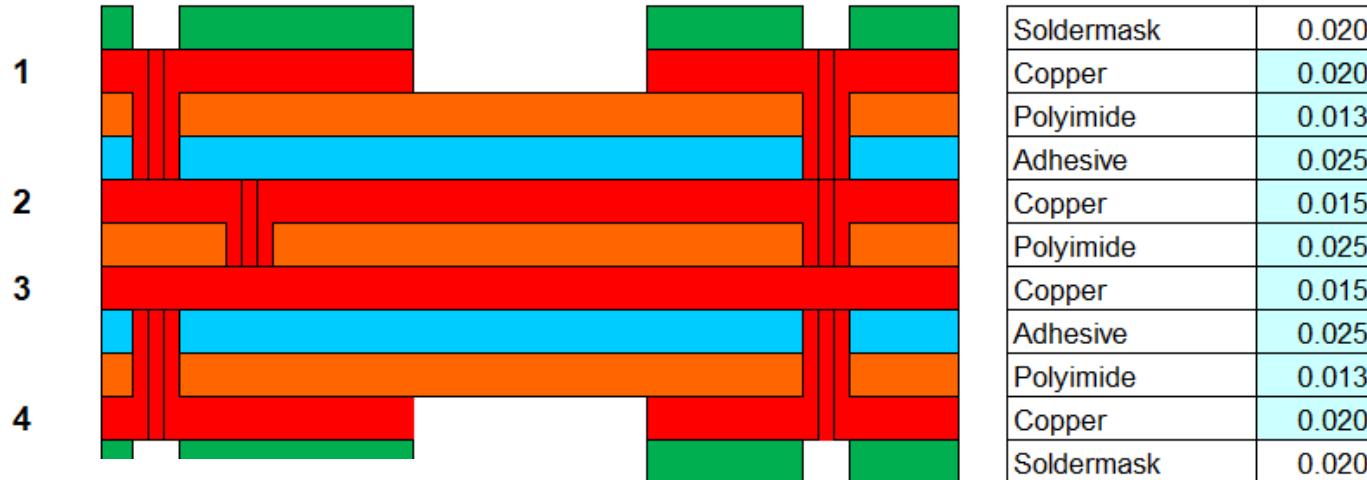


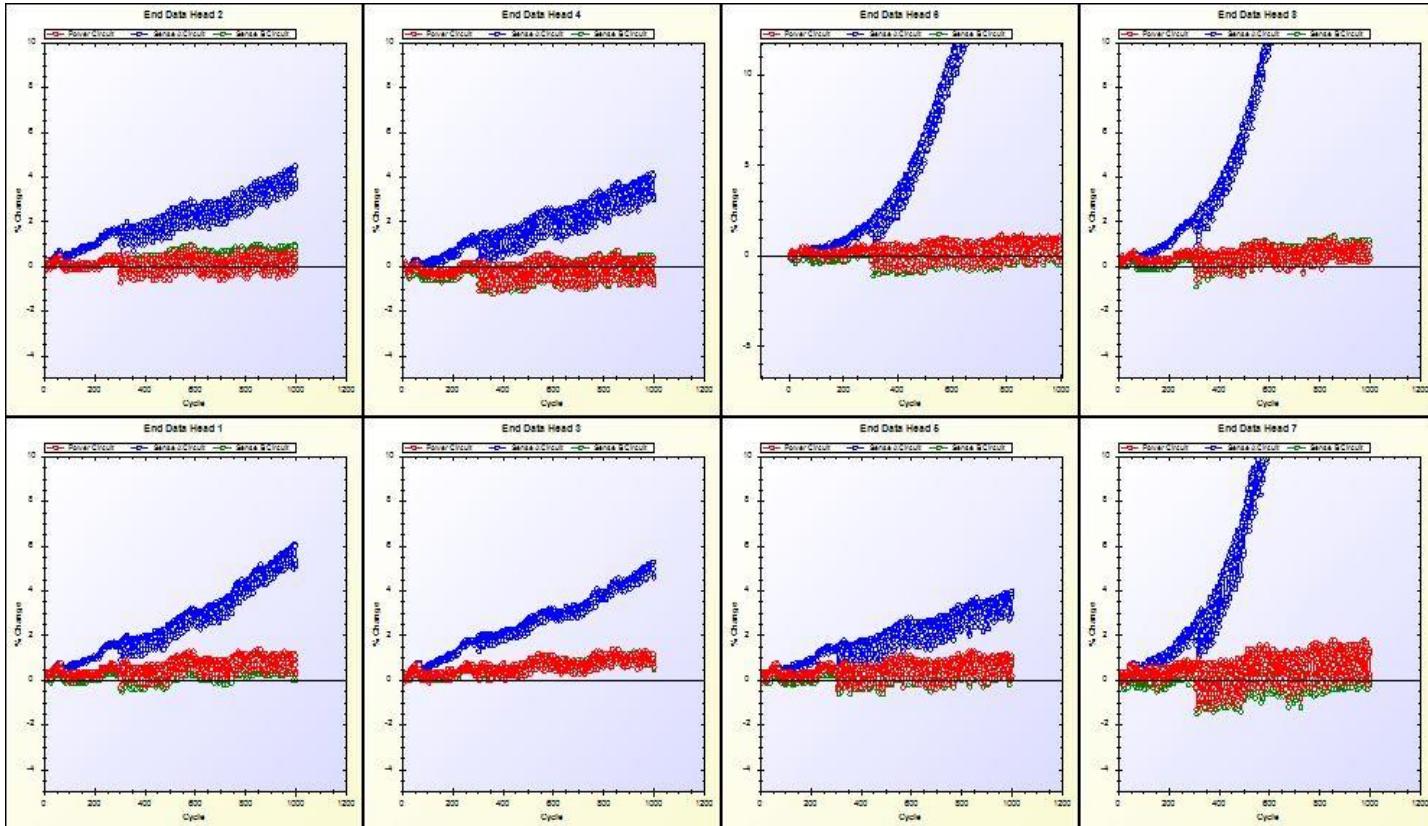
Cross Section – Fehlerbild (!)

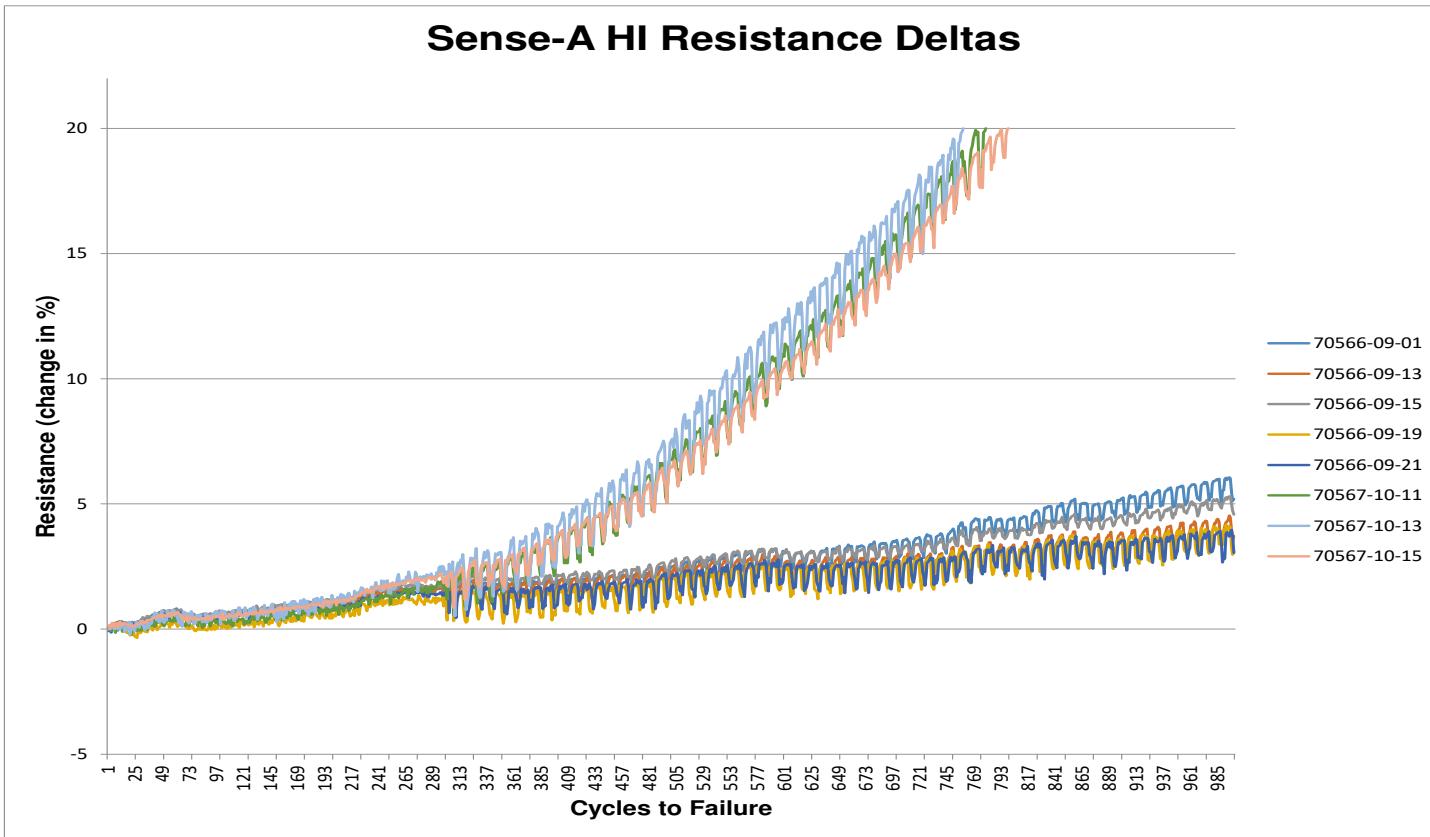


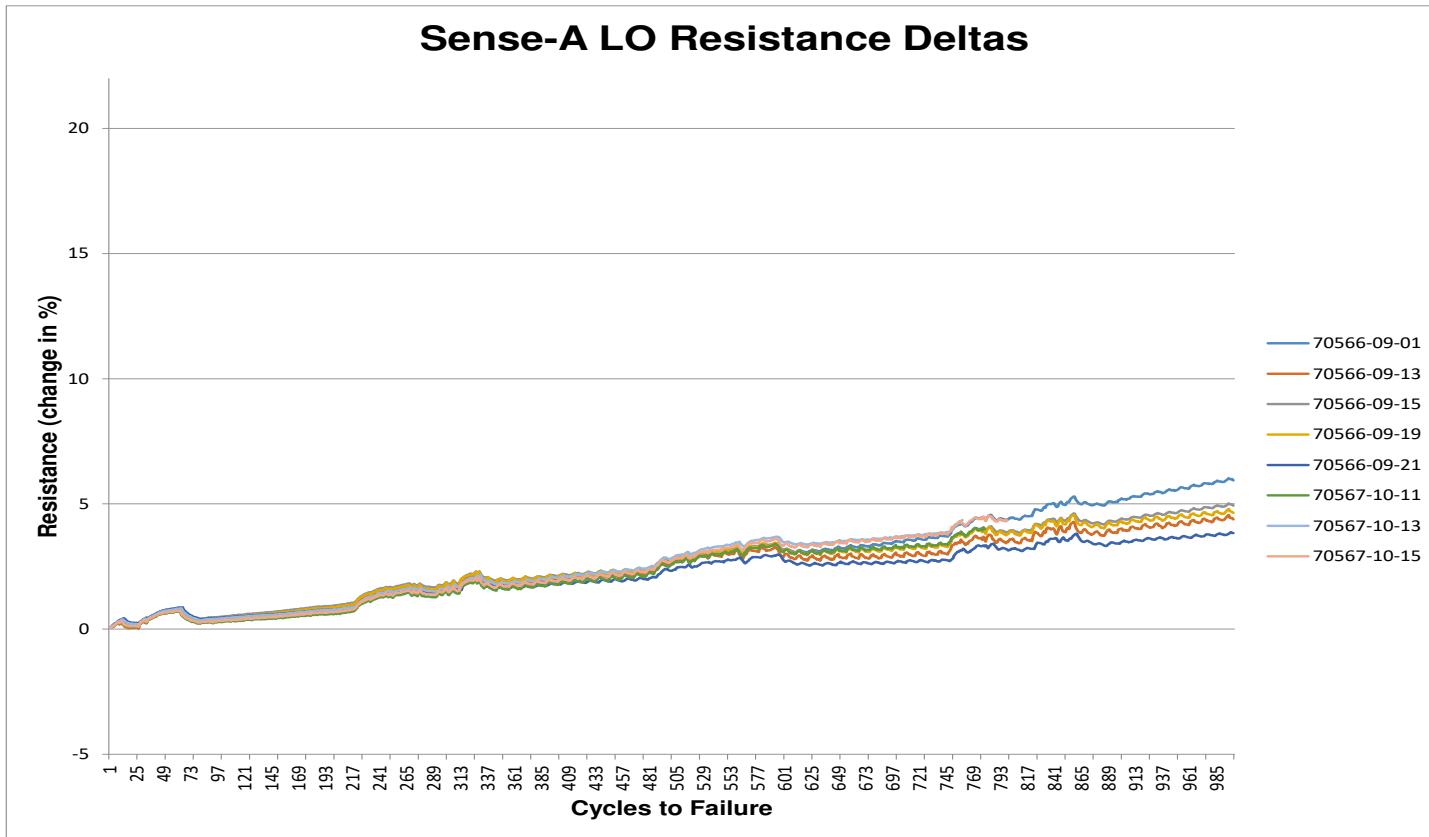


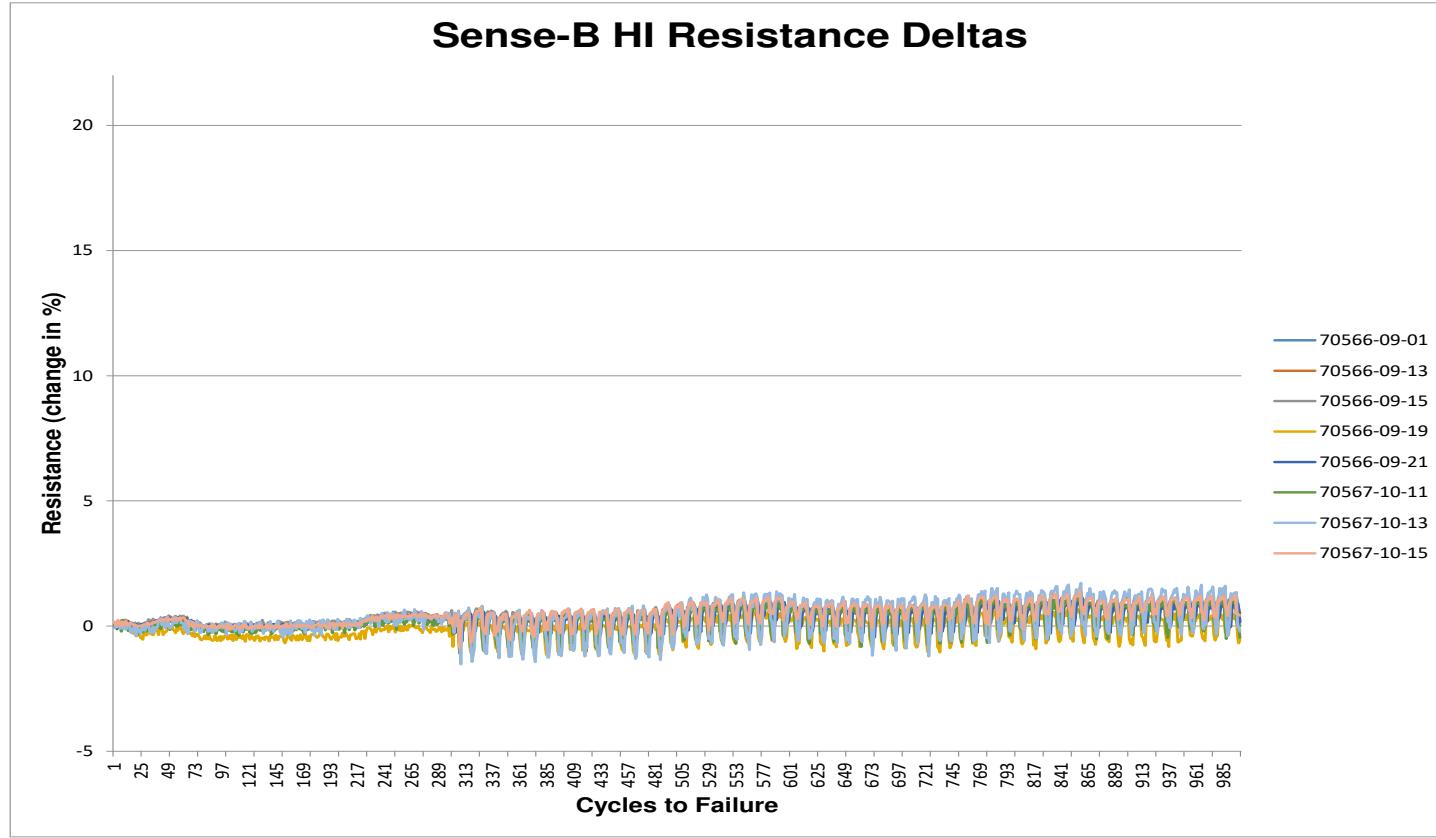
Typisches Abbruchkriterium nach IPC: 10% Widerstandserhöhung

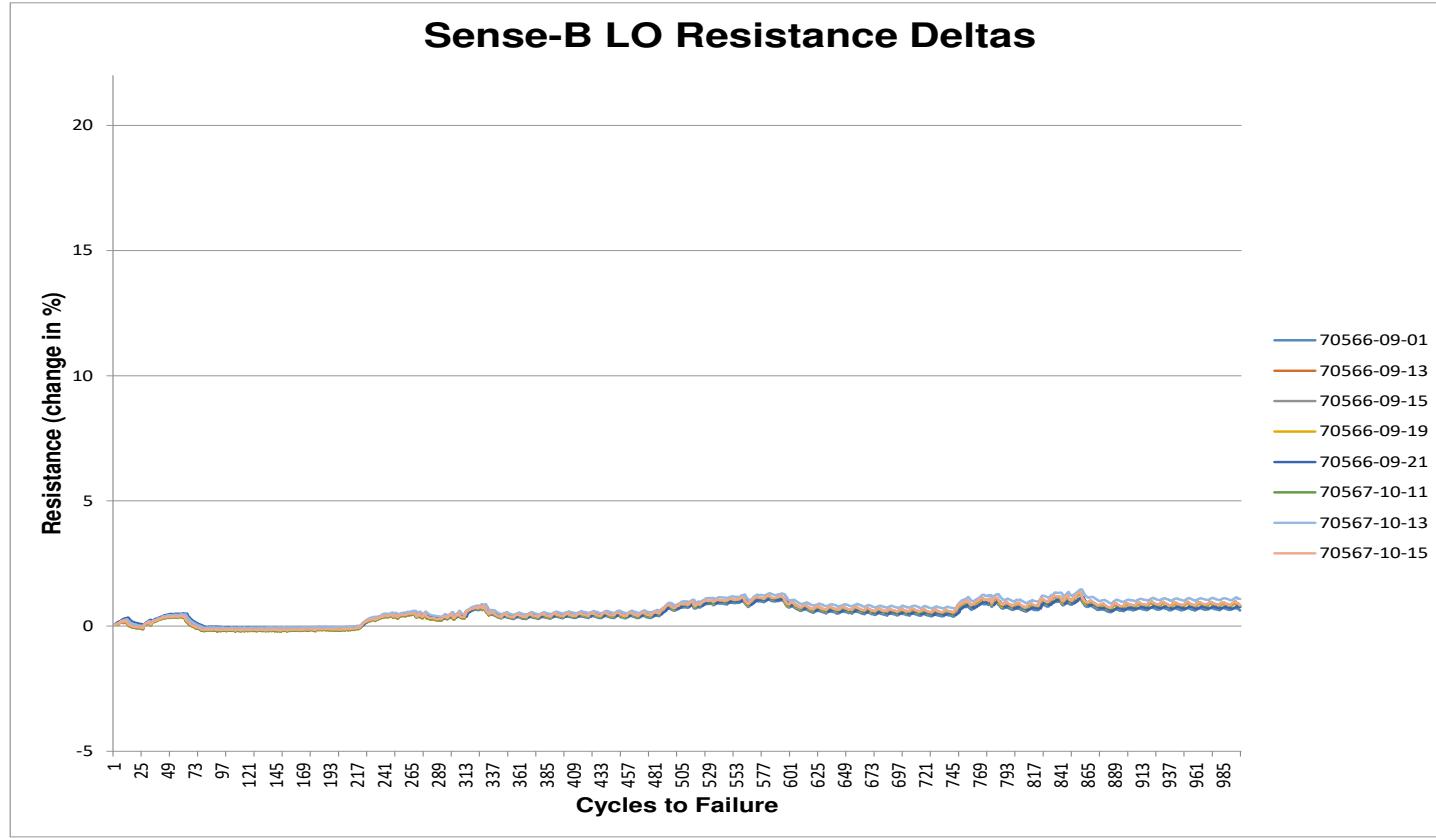




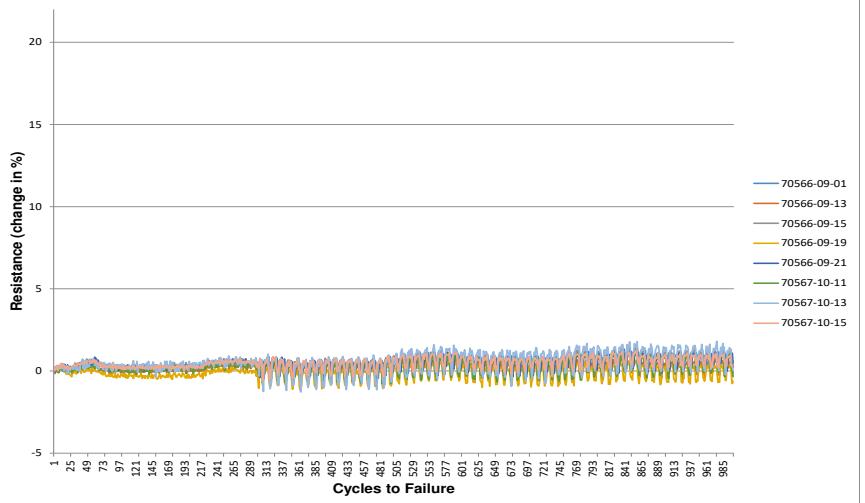




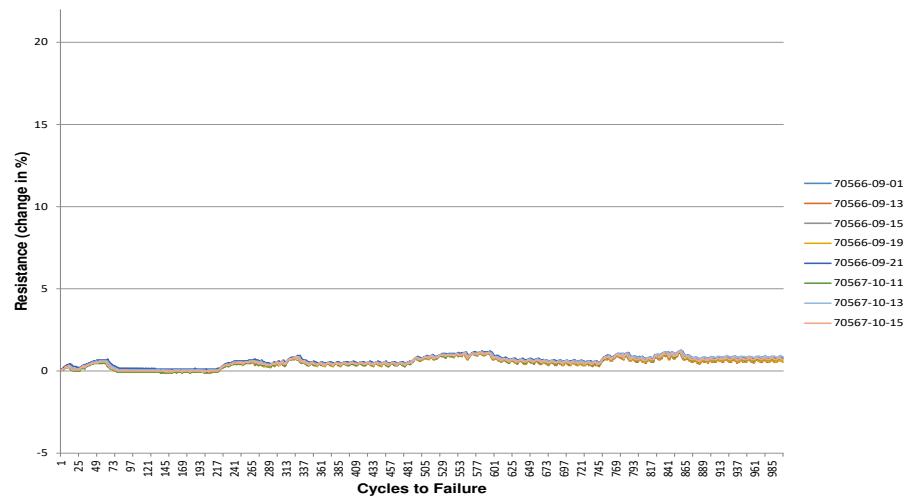


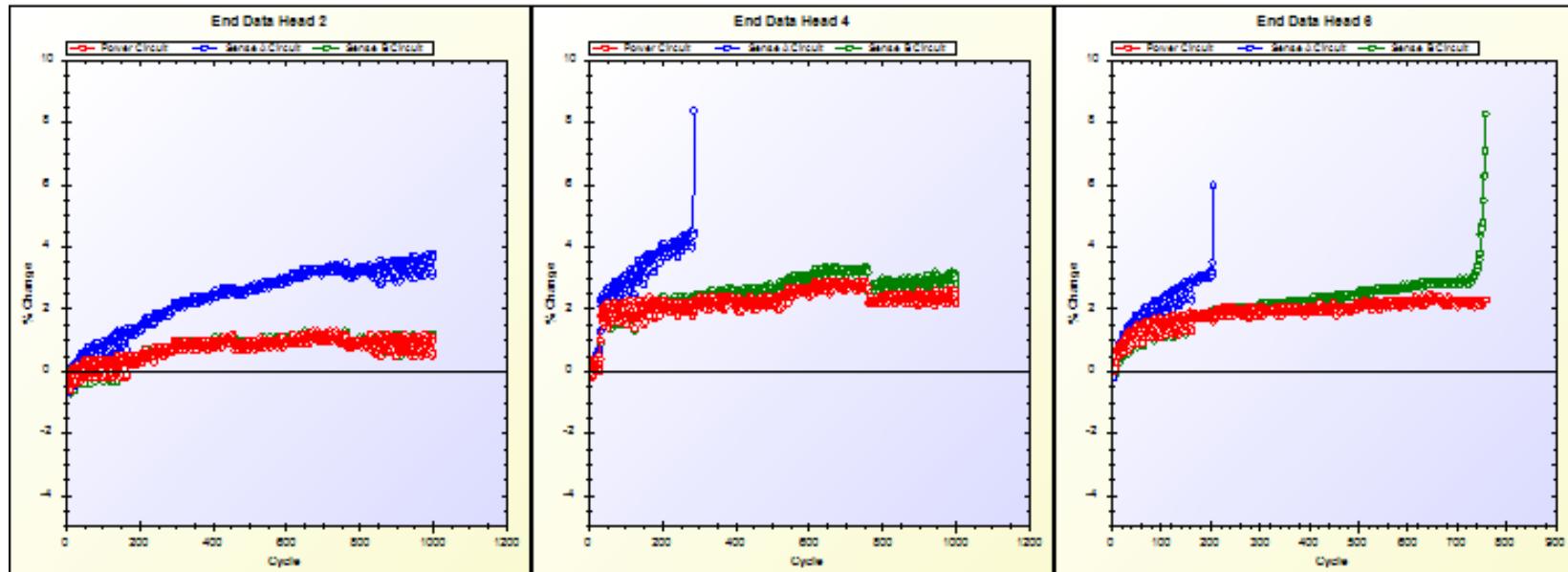


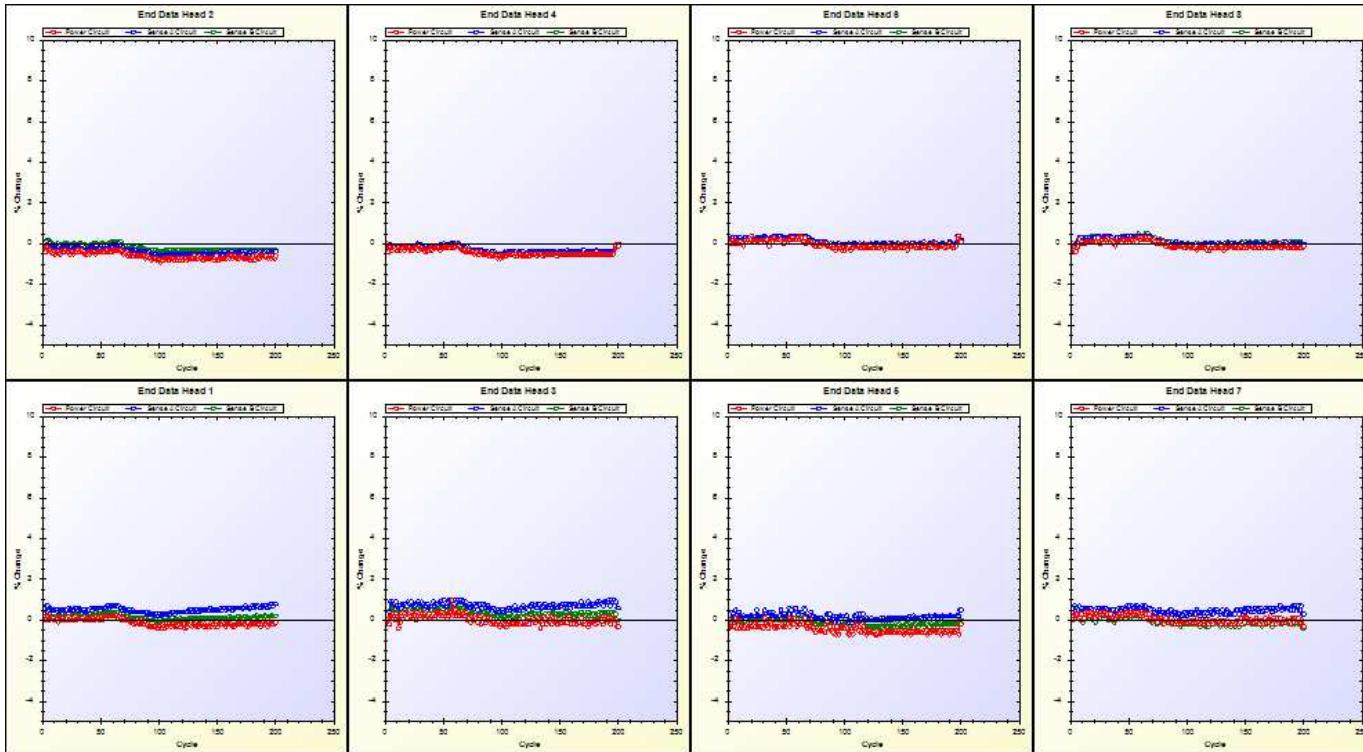
Power HI Resistance Deltas



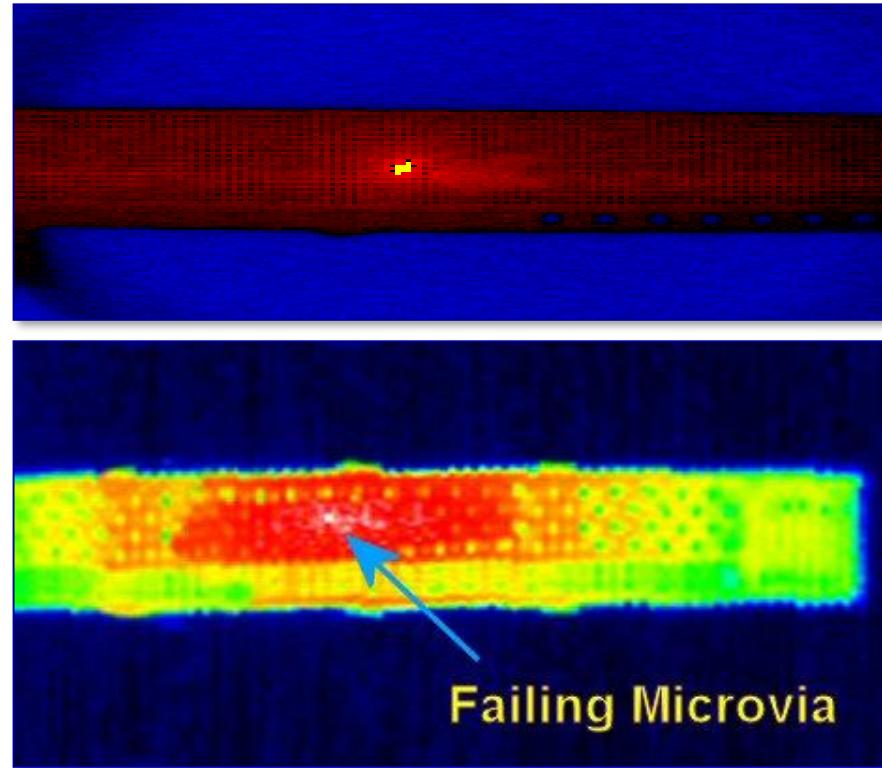
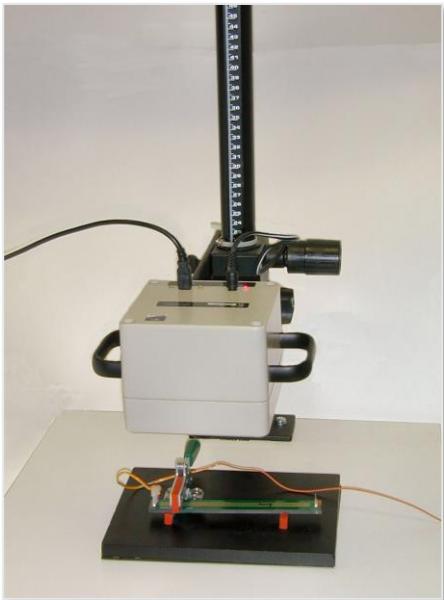
Power LO Resistance Deltas

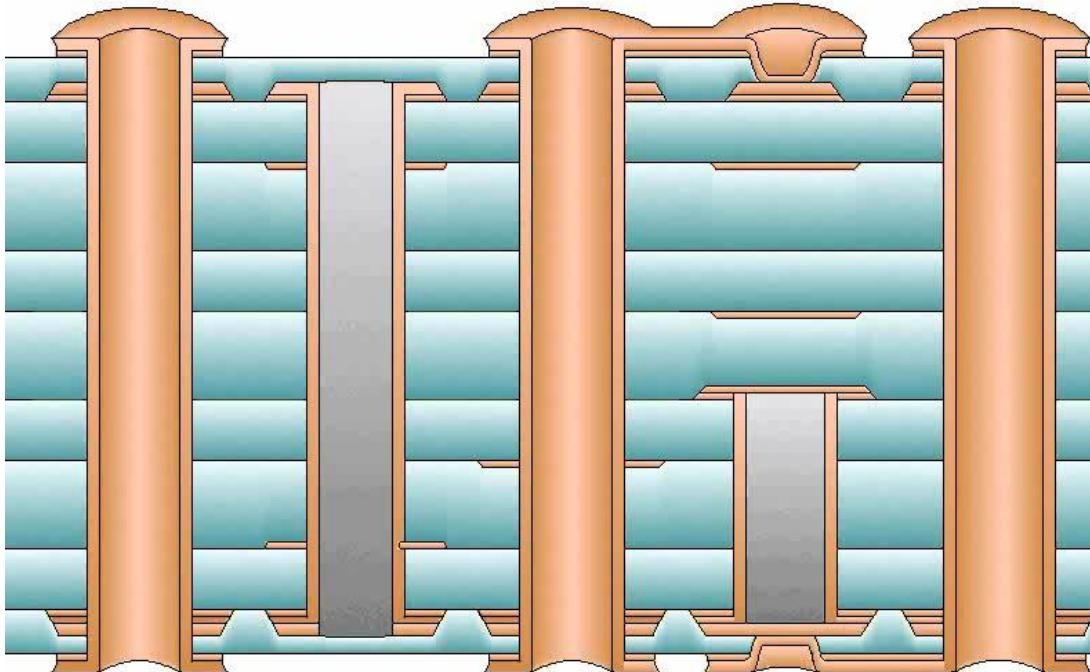


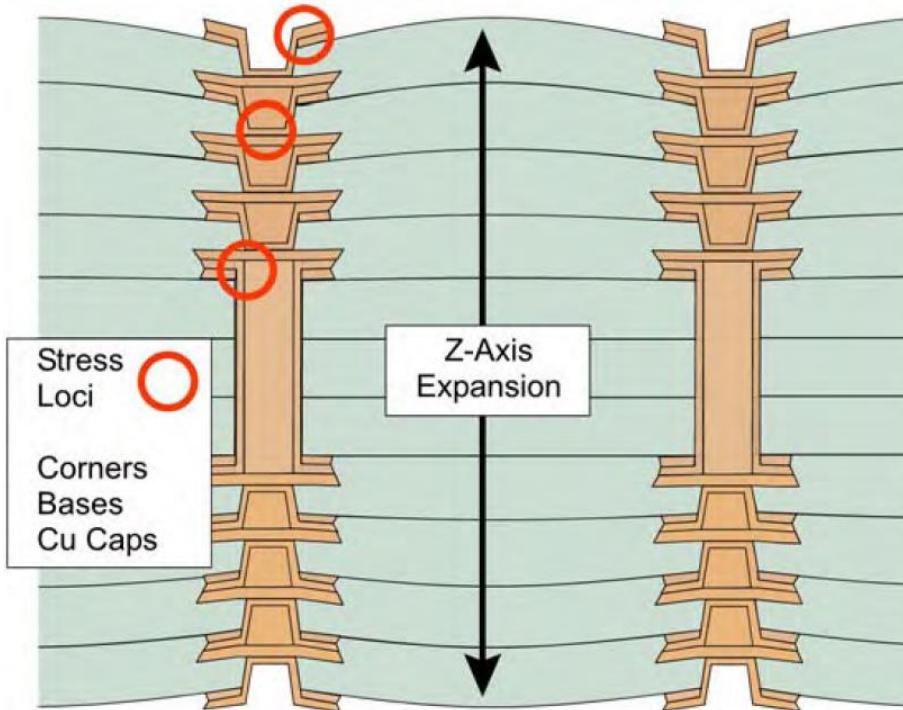




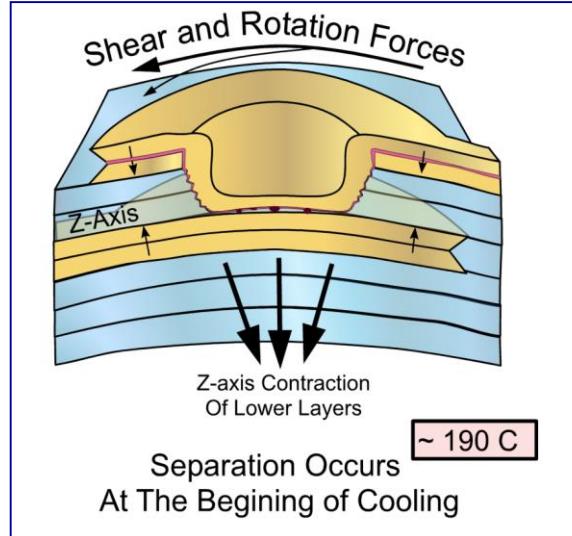
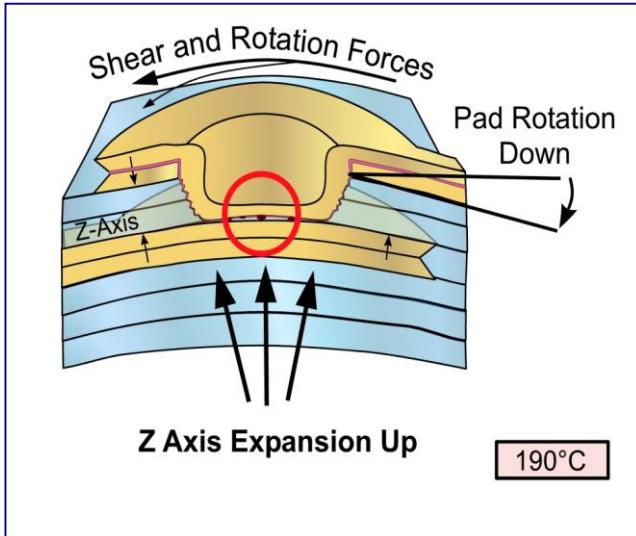
Fehlerlokalisierung Infrarot





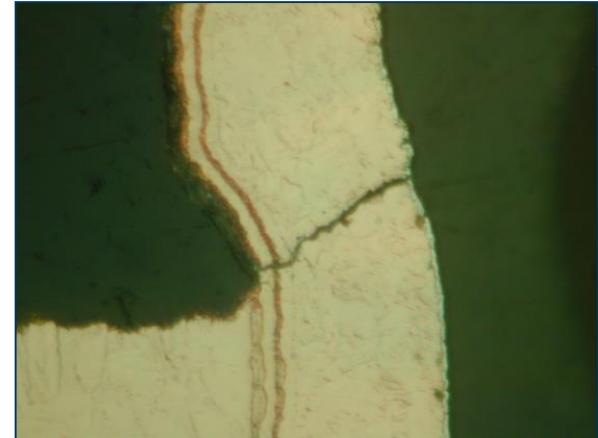
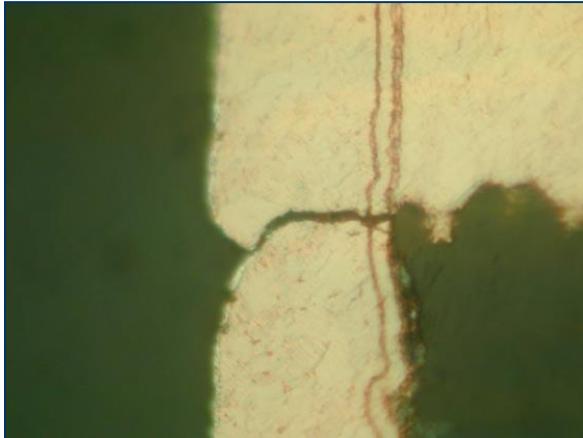


Microvia Targetpad Abriss

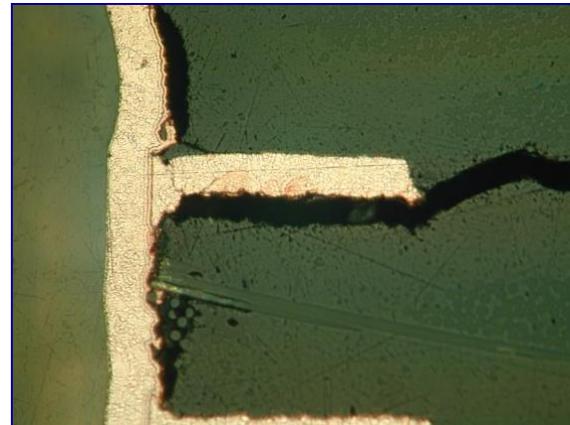


Abriss entsteht
erst bei der
Abkühlung(!)

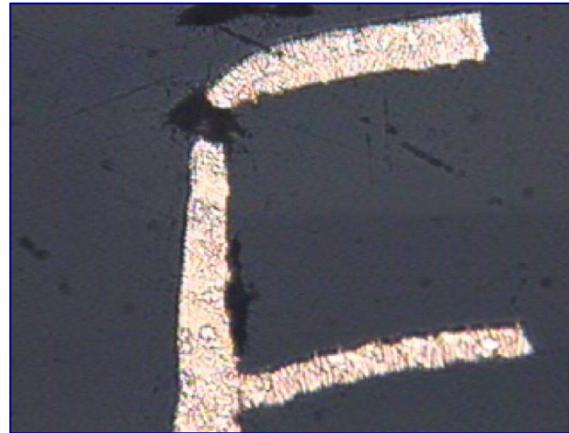
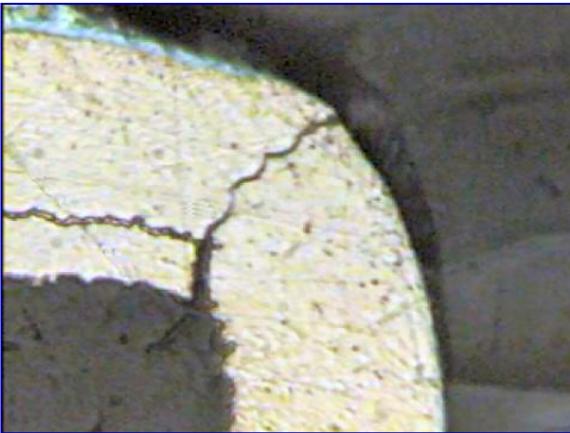
Fehlerbilder



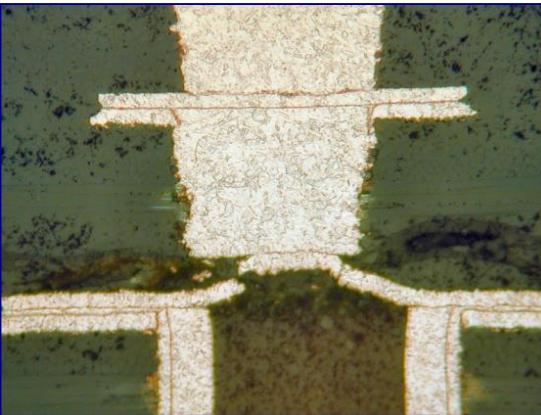
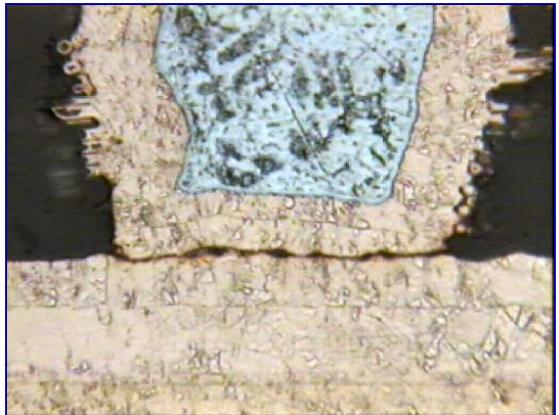
Fehlerbilder



Fehlerbilder



Fehlerbilder



Low CTE / thin rigid materials examples

- **BT Laminates (Mitsubishi, HL832NSF LCA)**
 - Very thin (starting with 15µm Laminate, 3µm Cu)
 - Low CTE (3/19)
 - High Tg (300°C)
 - Low Dk/Df (3.9 / 0.006)
 - High modulus
 - High stiffness
- **Epoxy based, halogen free (Hitachi MCL-E-700)**
 - 30µm Prepreg
 - Halogen free

Einflussgrößen auf Zyklenfestigkeit

- Temperatur
- Bohrdurchmesser
- Leiterplattendicke
- Ausdehnungskoeffizient des Dielektrikums
- Kupferschichtdicke in der Hülse
- Abstand der Bohrungen - Raster

Quality Management System

- ISO 9001:2015 and ISO 14001:2015
- EKAS safety requirements (since 2001)
- IPC-A-600 Certified IPC Trainer CIT
- IPC-A-600 Certified IPC Specialists CIS
- UL certified, E96683
- Not certified, but compliant to:
**ISO 13485, TS 16949, AS 9100, MIL-, ECSS-, AQAP-,
JEDEC-Standards**



Fachverband für Design,
Leiterplatten- & Elektronikfertigung



Metrology and reliability laboratory

- Automatic optical X,Y,Z measurement system, $\pm 5\mu\text{m}$
- Manual optical X,Y measurement system, $\pm 20\mu\text{m}$
- Measurement microscopes (X,Y,Z), $\pm 2\mu\text{m}$
- 3D Topography measurement system, $\pm 0.5\mu\text{m}$
- Microsection measurement microscope, $\pm 1\mu\text{m}$
- IST - Interconnection Stress Test (2016 & 2019 & 2022)
- Delamination Test System (2016)
- Metallographic section analysis
- Reflow Simulation
- Contamination measurement
- Thermal stress/shock test
- Thermography



Inhouse testing capabilities

- **X-Ray Fluorescence (XRF) SDD-Detector,**
limit. 2-5nm thickness
- **Impedance Control (Polar)**
- **Hi-potential testing**
- **Peel-Strength measurement system**
- **Temperature Cycle Test (TCT)**
- ...



Investments for better technology and throughput

- **New Schmoll laser (2022) & additional IST - Interconnection Stress Test (2022)**
- **New x-ray drilling machine (2022)**
- **New milling machines (2021) & new Plasma treatment (2021)**
- **New ESI laser – micro via laser (2020) & New Rivolino – rivet bonding (2020)**
- **New Ledia – direct Imaging (2019) & Additional AOI (2019)**
- **New in-house surface finish ISIG (2019)**
- **Microfill in-house (2019)**
- **Additional in-house IST – Interconnection Stress Test (2019)**
- **New in-house hole filling machine – epoxy (2018)**
- **Additional electrical test (2018)**
- **New milling machines (2017 & 2018 & 2019)**

Roadmap

Properties	2020	2022 Serial production	2022 R&D	2023	2025	2030
Project Line/Space [µm]	25/25	25/25	20/20	15/15	10/10	5/5
Etching tolerance [µm]	±8	±8	±5	±4	±4	±2
Layer/Layer tolerances [µm]	±20	±20	±20	±15	±15	±6
Min. Annular ring [µm] DL/ML	50/75	38/50	38/50	30/50	30/50	15/25
Soldermask Position [µm]	±30	±25	±25	±20	±20	±16
Milling/Layer tolerance [µm]	±40	±35	±35	±35	±35	±35
Min. Hole Size [µm] Laser/Mechanical	50/76	25/50	25/50	20/50	20/50	20/50
Min. Material thickness [µm] Flex/Rigid	12.5/50	12.5/35	8/-	8/-	5/-	4/-
Min. Copper Thickness [µm]	3	3	2	1	1	1
Degree of Automation	75 %	85 %	90 %	93 %	95 %	95 %

General design rules

Properties	Standard	Optimized	R&D
Copper Pattern Line/Space [µm]	75/75	50/50	35/35 (25/25)
Min. Annular ring [µm]	100	50	38
Min. Hole Size [µm] Laser/Mechanical	80/100	50/100	25/75
Pattern to Via Position / Soldermask to Pattern Position [µm]	±100	±50	±38
Outline/Pattern tolerance [µm]	±100	±50	±35
Min. Pitch [µm]	355/375	200/250	135/185

General Guideline. Please confirm your specific design rules for your product with our experts

Why Optiprint ?

- **Products 100% made in Switzerland**
- **Customized solutions**
- **An organization at your service**
- **High quality and reliability**
- **Competence and knowledge**
- **From single pieces to mass production**
- **Top certifications**
- **Top customer support**



Contact / Engineering



Optiprint

■ Innovative PCB Solutions



Michael Sorger

CTO, Technologie Center
Tel +41 71 747 86 44
Email m.sorger@optiprint.ch



Jason Deane

Senior VP Technologie Center
Tel +41 71 747 86 18
Email j.deane@optiprint.ch



Dragan Jelecevic

Project Manager
Tel +41 71 747 86 24
Email d.jelecevic@optiprint.ch



Sascha Savic

Project Manager
Tel +41 71 747 86 32
Email s.savic@optiprint.ch



Eren Bektas

Project Manager
Tel +41 71 747 86 42
Email e.bektas@optiprint.ch



Marc Lötscher

Project Manager
Tel +41 71 747 86 16
Email m.loetscher@optiprint.ch



Tanja Blöchligner

Project Manager
Tel +41 71 747 86 50
Email t.bloechlinger@optiprint.ch

Contact / Sales



Pascal Oberson
CSO
Switzerland, France
Tel +41 71 747 86 34
Email p.oberson@optiprint.ch



Gerhard Popp
Germany, Eastern Europe, Asia
Tel +49 7129 922 783
Mobile +49 1728 259 290
Email gerhard.popp@t-online.de



Jim Francey
UK, Northern Europe
Tel +44 7768 582611
Email j.francey@optiprint.co.uk



Claudio Marziali
Italy
Tel +39 06 663 17 44
Email claudio.marziali@alfamicroonde.com



Margit Mills
USA
Mobile +1 312 925 3861
Email m.mills@optiprint.ch



Alexander Popp
Senior Vice President Sales
Tel +41 71 747 86 14
Email a.poppe@optiprint.ch

Optiprint

■ Innovative PCB Solutions



→ **Optiprint AG**

sales@optiprint.ch www.optiprint.ch